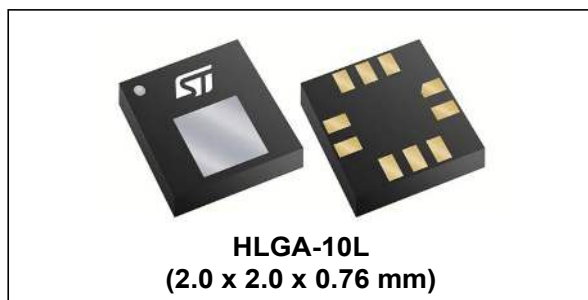


## High-performance MEMS nano pressure sensor: 260-1260 hPa absolute digital output barometer

Datasheet - production data



### Applications

- Altimeters and barometers for portable devices
- GPS applications
- Weather station equipment
- Sport watches
- e-cigarettes
- Gas metering

### Features

- 260 to 1260 hPa absolute pressure range
- Current consumption down to 4  $\mu$ A
- Low pressure sensor noise: 0.75 Pa
- Relative pressure accuracy: 10 Pa
- Embedded temperature compensation
- 24-bit pressure data output
- ODR from 1 Hz to 200 Hz
- SPI, I<sup>2</sup>C interfaces
- Embedded FIFO
- Interrupt functions: Data-Ready, FIFO flags, pressure thresholds
- Supply voltage: 1.7 to 3.6 V
- High shock survivability: 22,000 g
- Small and thin package
- ECOPACK lead-free compliant

### Description

The LPS22CH is an ultra-compact piezoresistive absolute pressure sensor which functions as a digital output barometer. The device comprises a sensing element and an IC interface which communicates through I<sup>2</sup>C or SPI from the sensing element to the application.

The sensing element, which detects absolute pressure, consists of a suspended membrane manufactured using a dedicated process developed by ST.

The LPS22CH is available in a full-mold, holed LGA package (HLGA). It is guaranteed to operate over a temperature range extending from -40 °C to +85 °C. The package is holed to allow external pressure to reach the sensing element.

**Table 1. Device summary**

Order code	Temperature range [°C]	Package	Packing
LPS22CHTR	-40 to +85°C	HLGA-10L	Tape and reel

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# 1 Block diagrams

Figure 1. Device architecture block diagram

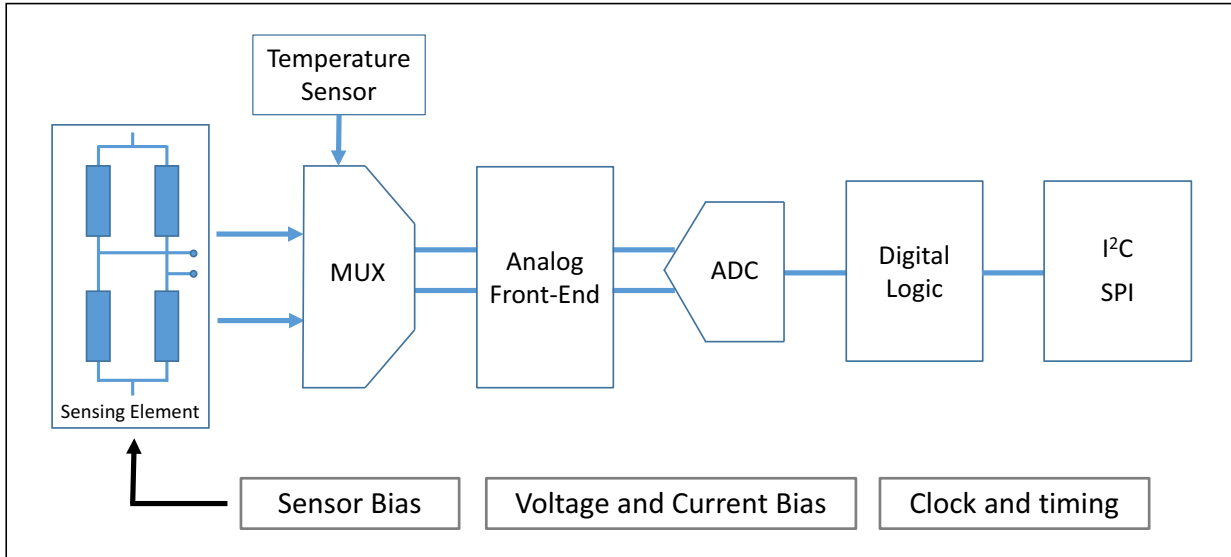
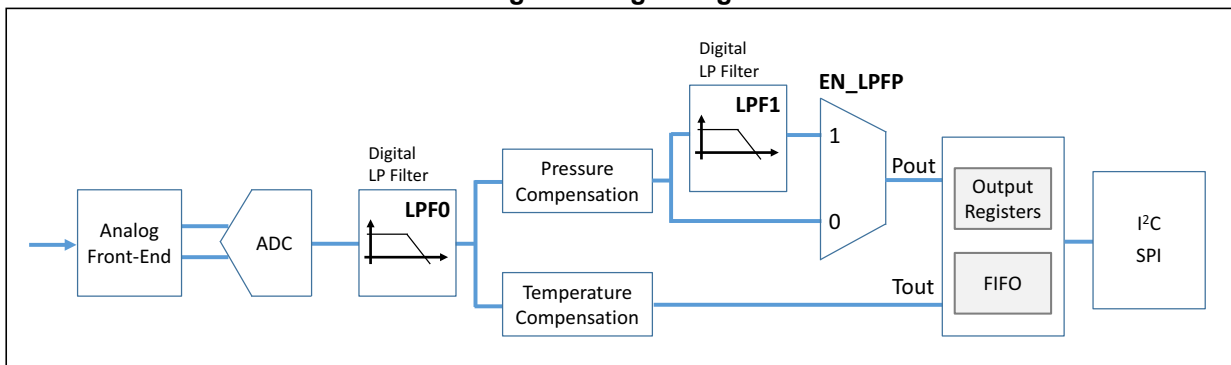


Figure 2. Digital logic



## 2 Pin description

Figure 3. Pin connections (bottom view)

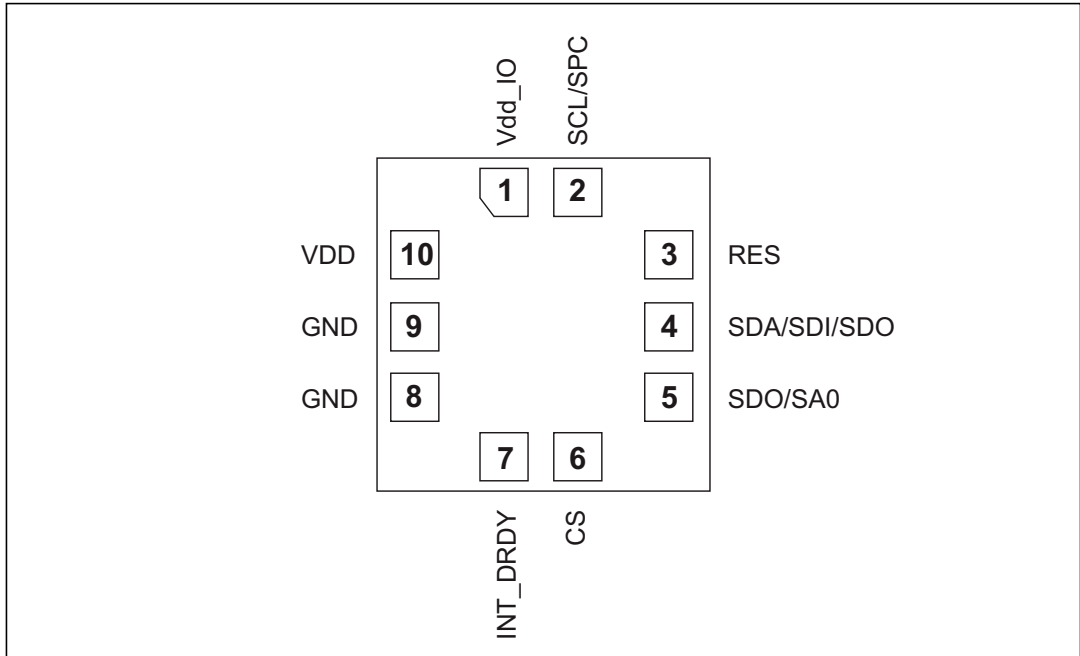


Table 2. Pin description

Pin number	Name	Function
1	Vdd_IO	Power supply for I/O pins
2	SCL SPC	I <sup>2</sup> C serial clock (SCL) SPI serial port clock (SPC)
3	Reserved	Connect to GND
4	SDA SDI SDI/SDO	I <sup>2</sup> C serial data (SDA) 4-wire SPI serial data input (SDI) 3-wire serial data input/output (SDI/SDO)
5	SDO SA0	4-wire SPI serial data output (SDO) I <sup>2</sup> C least significant bit of the device address (SA0)
6	CS	SPI enable I <sup>2</sup> C / SPI mode selection (1: SPI idle mode / I <sup>2</sup> C communication enabled; 0: SPI communication mode / I <sup>2</sup> C disabled)
7	INT_DRDY	Interrupt or Data-Ready
8	GND	0 V supply
9	GND	0 V supply
10	VDD	Power supply



### 3 Mechanical and electrical specifications

#### 3.1 Mechanical characteristics

VDD = 1.8 V, T = 25 °C, unless otherwise noted.

**Table 3. Pressure and temperature sensor characteristics**

Symbol	Parameter	Test condition	Min.	Typ. <sup>(1)</sup>	Max.	Unit
<b>Pressure sensor characteristics</b>						
P <sub>T<sub>op</sub></sub>	Operating temperature range		-40		+85	°C
P <sub>op</sub>	Operating pressure range		260		1260	hPa
P <sub>bits</sub>	Pressure output data			24		bits
P <sub>sens</sub>	Pressure sensitivity			4096		LSB/ hPa
P <sub>AccRel</sub>	Relative accuracy over pressure <sup>(2)</sup>	P = 800 - 1100 hPa T = 25 °C		±0.1		hPa
P <sub>AccT</sub>	Absolute accuracy over temperature	P <sub>op</sub> , T = 0 ~ 65 °C		±1		hPa
P <sub>noise</sub>	RMS pressure sensor noise <sup>(3)</sup>	with embedded filter and at T = 25 °C		0.75		Pa RMS
ODR <sub>Pres</sub>	Pressure output data rate <sup>(4)</sup>			1 10 25 50 75 100 200		Hz
P <sub>longterm</sub>	Pressure accuracy, long-term stability <sup>(5)</sup>			1		hPa/year
P <sub>drift</sub>	Soldering drift			±1		hPa
<b>Temperature sensor characteristics</b>						
T <sub>op</sub>	Operating temperature range		-40		+85	°C
T <sub>sens</sub>	Temperature sensitivity			100		LSB/°C
ODR <sub>T</sub>	Output temperature data rate <sup>(4)</sup>			1 10 25 50 75 100 200		Hz

1. Typical specifications are not guaranteed.

2. By design, the typ. value is defined based characterization data with 10 hPa pressure interval.

3. Pressure noise RMS evaluated in a controlled environment, based on the average standard deviation of 50 measurements with LOW\_NOISE\_EN = 1, EN\_LPFP = 1, LPFP\_CFG = 1.
4. Output data rate is configured acting on ODR[2:0] in CTRL\_REG1 (10h).
5. Typ. value is defined considering a 5-year life cycle of the final application.

### 3.2 Electrical characteristics

VDD = 1.8 V, T = 25 °C, unless otherwise noted.

**Table 4. Electrical characteristics**

Symbol	Parameter	Test condition	Min.	Typ. <sup>(1)</sup>	Max.	Unit
VDD	Supply voltage		1.7		3.6	V
Vdd_IO	IO supply voltage		1.7		Vdd+0.1	V
Idd	Supply current	@ ODR 1 Hz LOW_NOISE_EN = 0		4		µA
		@ ODR 1 Hz LOW_NOISE_EN = 1		12		
IddPdn	Supply current in power-down mode			0.9		µA

1. Typical specifications are not guaranteed.

**Table 5. DC characteristics**

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
<b>DC input characteristics</b>						
Vil	Low-level input voltage (Schmitt buffer)	-	-	-	0.2 * Vdd_IO	V
Vih	High-level input voltage (Schmitt buffer)	-	0.8 * Vdd_IO	-	-	V
<b>DC output characteristics</b>						
Vol	Low-level output voltage		-	-	0.2	V
Voh	High-level output voltage		Vdd_IO - 0.2	-	-	V

### 3.3 Communication interface characteristics

#### 3.3.1 SPI - serial peripheral interface

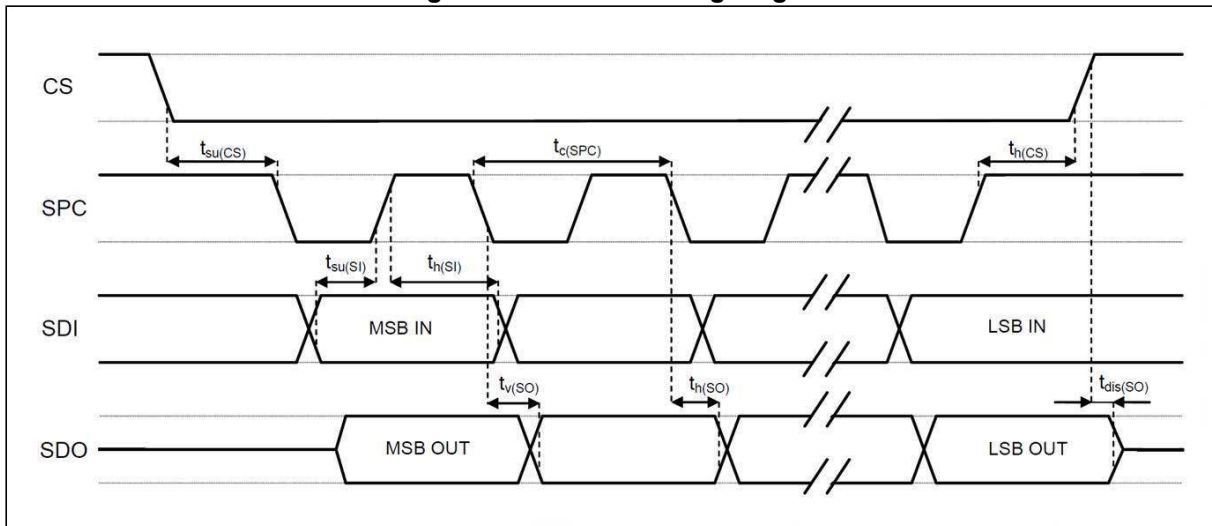
Subject to general operating conditions for V<sub>DD</sub> and T<sub>OP</sub>.

**Table 6. SPI slave timing values**

Symbol	Parameter	Value <sup>(1)</sup>		Unit
		Min	Max	
t <sub>c(SPC)</sub>	SPI clock cycle	100		ns
f <sub>c(SPC)</sub>	SPI clock frequency		10 <sup>(2)</sup>	MHz
t <sub>su(CS)</sub>	CS setup time	6		ns
t <sub>h(CS)</sub>	CS hold time	8		
t <sub>su(SI)</sub>	SDI input setup time	5		
t <sub>h(SI)</sub>	SDI input hold time	15		
t <sub>v(SO)</sub>	SDO valid output time		50	
t <sub>h(SO)</sub>	SDO output hold time	9		
t <sub>dis(SO)</sub>	SDO output disable time		50	

1. Values are guaranteed at 10 MHz clock frequency for SPI with both 4 and 3 wires, based on characterization results, not tested in production.
2. Recommended to set max SPI clock 8 MHz to ≤50 Hz ODR.

**Figure 4. SPI slave timing diagram**



Note: Measurement points are done at 0.2·V<sub>DD\_IO</sub> and 0.8·V<sub>DD\_IO</sub>, for both ports.

### 3.3.2 I<sup>2</sup>C - inter-IC control interface

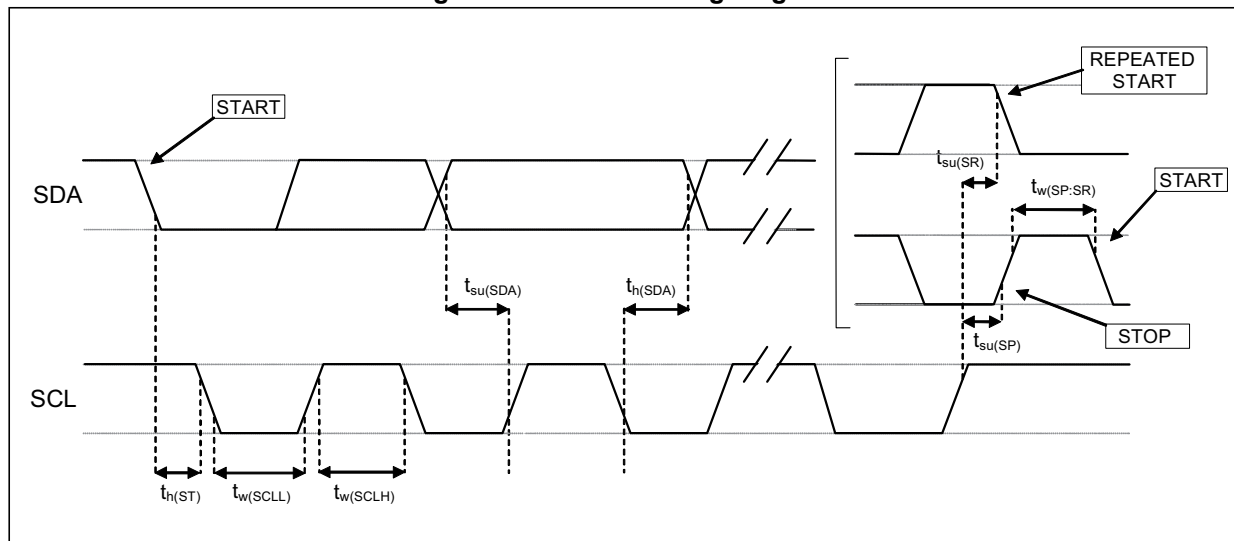
Subject to general operating conditions for V<sub>DD</sub> and T<sub>OP</sub>

**Table 7. I<sup>2</sup>C slave timing values**

Symbol	Parameter (1)	I <sup>2</sup> C standard mode <sup>(1)</sup>		I <sup>2</sup> C fast mode <sup>(1)</sup>		Unit
		Min	Max	Min	Max	
f <sub>(SCL)</sub>	SCL clock frequency	0	100	0	400	kHz
t <sub>w(SCLL)</sub>	SCL clock low time	4.7		1.3		μs
t <sub>w(SCLH)</sub>	SCL clock high time	4.0		0.6		
t <sub>su(SDA)</sub>	SDA setup time	250		100		ns
t <sub>h(SDA)</sub>	SDA data hold time	0	3.45	0	0.9	μs
t <sub>h(ST)</sub>	START condition hold time	4		0.6		μs
t <sub>su(SR)</sub>	Repeated START condition setup time	4.7		0.6		
t <sub>su(SP)</sub>	STOP condition setup time	4		0.6		
t <sub>w(SP:SR)</sub>	Bus free time between STOP and START condition	4.7		1.3		

1. Data based on standard I<sup>2</sup>C protocol requirement, not tested in production.

**Figure 5. I<sup>2</sup>C slave timing diagram**



Note: Measurement points are done at 0.2·V<sub>DD\_IO</sub> and 0.8·V<sub>DD\_IO</sub>, for both ports.

### 3.4 Absolute maximum ratings

Stress above those listed as “Absolute maximum ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

**Table 8. Absolute maximum ratings**

Symbol	Ratings	Maximum value	Unit
Vdd	Supply voltage	-0.3 to 4.8	V
Vdd_IO	I/O pins supply voltage	-0.3 to 4.8	V
Vin	Input voltage on any control pin	-0.3 to Vdd_IO +0.3	V
P	Overpressure	2	MPa
T <sub>STG</sub>	Storage temperature range	-40 to +125	°C
ESD	Electrostatic discharge protection	2.5 (HBM)	kV

*Note:* Supply voltage on any pin should never exceed 4.8 V.



This device is sensitive to mechanical shock, improper handling can cause permanent damage to the part.



This device is sensitive to electrostatic discharge (ESD), improper handling can cause permanent damage to the part.

## 4 Functionality

The LPS22CH is a high-resolution, digital output pressure sensor packaged in an HLGA full-mold package. The complete device includes a sensing element based on a piezoresistive Wheatstone bridge approach, and an IC interface which communicates a digital signal from the sensing element to the application.

### 4.1 Sensing element

An ST proprietary process is used to obtain a silicon membrane for MEMS pressure sensors. When pressure is applied, the membrane deflection induces an imbalance in the Wheatstone bridge piezoresistances whose output signal is converted by the IC interface.

### 4.2 IC interface

The complete measurement chain is composed of a low-noise amplifier which converts the resistance unbalance of the MEMS sensors (pressure and temperature) into an analog voltage using an analog-to-digital converter.

The pressure and temperature data may be accessed through an I<sup>2</sup>C/SPI interface thus making the device particularly suitable for direct interfacing with a microcontroller.

The LPS22CH features a Data-Ready signal which indicates when a new set of measured pressure and temperature data are available, thus simplifying data synchronization in the digital system that uses the device.

### 4.3 Factory calibration

The trimming values are stored inside the device in a non-volatile structure. When the device is turned on, the trimming parameters are downloaded into the registers to be employed during the normal operation which allows the device to be used without requiring any further calibration.

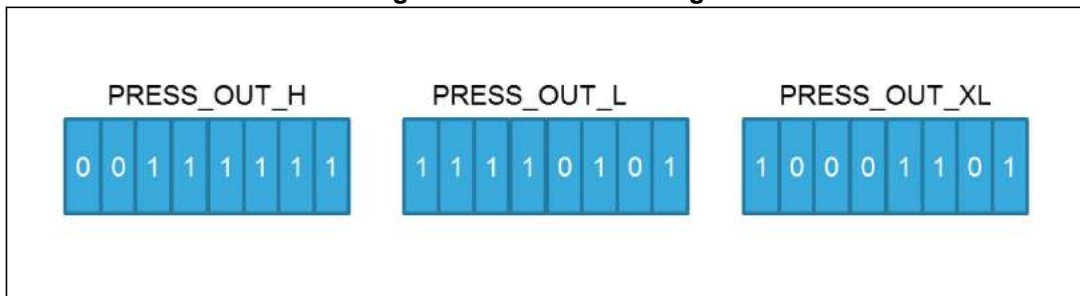
## 4.4 Interpreting pressure readings

The pressure data are stored in 3 registers: *PRESS\_OUT\_H (2Ah)*, *PRESS\_OUT\_L (29h)*, and *PRESS\_OUT\_XL (28h)*. The value is expressed as a 24-bit signed number (in 2's complement).

To obtain the pressure in hPa, take the complete 24-bit word and then divide by the sensitivity 4096 LSB/hPa. This same interpretation is applied to pressure readings when FIFO is enabled and the pressure data are stored in 3 registers:

*FIFO\_DATA\_OUT\_PRESS\_XL (78h)*, *FIFO\_DATA\_OUT\_PRESS\_L (79h)*, and *FIFO\_DATA\_OUT\_PRESS\_H (7Ah)*.

**Figure 6. Pressure readings**



### Equation 1

$$\begin{aligned} \text{Pressure Value (LSB)} &= \text{PRESS\_OUT\_H (2Ah)} \& \text{PRESS\_OUT\_L (29h)} \& \text{PRESS\_OUT\_XL (28h)} \\ &= 3FF58Dh = 4191629 \text{ LSB (signed decimal)} \end{aligned}$$

### Equation 2

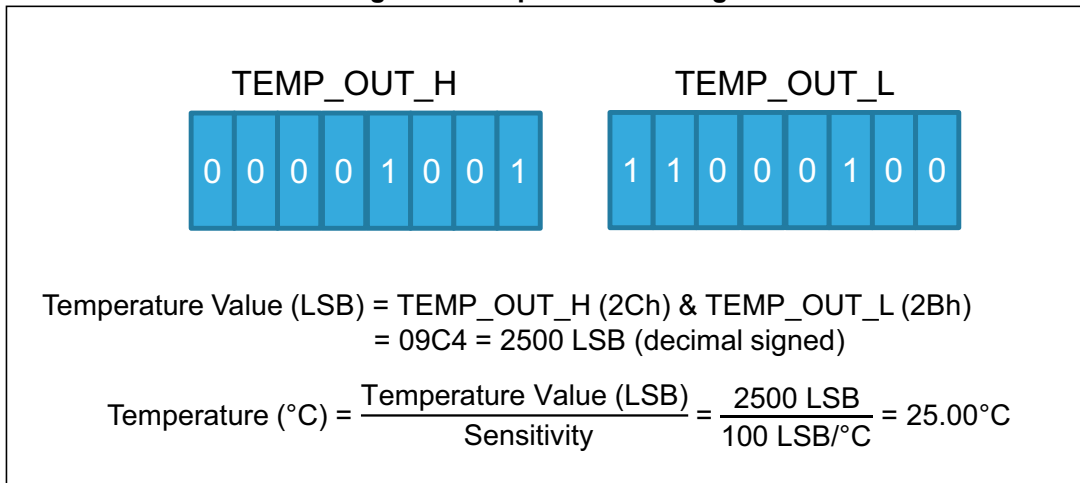
$$\text{Pressure (hPa)} = \frac{\text{Pressure Value (LSB)}}{\text{Sensitivity}} = \frac{4191629 \text{ LSB}}{4096 \text{ LSB/hPa}} = 1023.3 \text{ hPa}$$

### 4.5 Interpreting temperature readings

The temperature data are stored in 2 registers: *TEMP\_OUT\_H (2Ch)* and *TEMP\_OUT\_L (2Bh)*.

The value is expressed as 2's complement. To obtain the temperature in °C, take the two's complement of the complete 16-bit word and then divide by the sensitivity 100 LSB/°C. This same interpretation is applied to temperature readings when FIFO is enabled and the temperature data are stored in 2 registers: *FIFO\_DATA\_OUT\_TEMP\_H (7Ch)* and *FIFO\_DATA\_OUT\_TEMP\_L (7Bh)*.

**Figure 7. Temperature readings**





## 5 FIFO

The LPS22CH embeds 128 slots of 40-bit data FIFO to store the pressure and temperature output values. This allows consistent power saving for the system, since the host processor does not need to continuously poll data from the sensor, but it can wake up only when needed and burst the significant data out from the FIFO. This buffer can work according to six different modes:

- Bypass mode
- FIFO mode
- Continuous (Dynamic-Stream) mode
- Continuous (Dynamic-Stream)-to-FIFO mode
- Bypass-to-Continuous (Dynamic-Stream)
- Bypass-to-FIFO mode

The FIFO buffer is enabled when a configuration different from all bits '0' are written in [FIFO\\_CTRL \(13h\)](#) and each mode is selected by the TRIG\_MODES bit and F\_MODE[1:0] bits in [FIFO\\_CTRL \(13h\)](#). Programmable FIFO threshold status, FIFO overrun events and the number of unread samples stored are available in the [FIFO\\_STATUS1 \(25h\)](#) and [FIFO\\_STATUS2 \(26h\)](#) registers and can be set to generate dedicated interrupts on the INT\_DRDY pad using the [CTRL\\_REG3 \(12h\)](#) register.

[FIFO\\_STATUS2 \(26h\)](#)(FIFO\_WTM\_IA) goes to '1' when the number of unread samples ([FIFO\\_STATUS1 \(25h\)](#)(FSS[7:0]) is greater than or equal to WTM[6:0] in [FIFO\\_WTM \(14h\)](#). If [FIFO\\_WTM \(14h\)](#)(WTM[6:0]) is equal to 0, [FIFO\\_STATUS2 \(26h\)](#)(FIFO\_WTM\_IA) stays at '0'.

[FIFO\\_STATUS2 \(26h\)](#)(FIFO\_OVR\_IA) is equal to '1' if a FIFO slot is overwritten.

[FIFO\\_STATUS1 \(25h\)](#)(FSS[7:0]) contains stored data levels of unread samples; when FSS[7:0] is equal to '00000000', FIFO is empty; when FSS[7:0] is equal to '10000000', FIFO is full and the unread samples are 128.

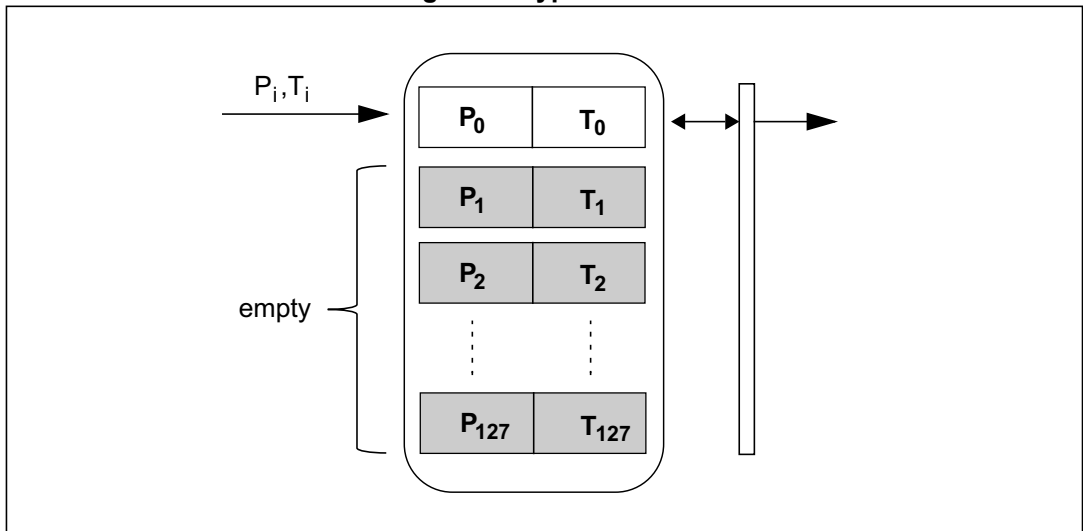
### 5.1 Bypass mode

In Bypass mode (*FIFO\_CTRL (13h)*(TRIG\_MODES and F\_MODE[1:0] = '000' or '100'), the FIFO is not operational and it remains empty.

Switching to Bypass mode is also used to reset the FIFO. Passing through Bypass mode is mandatory when switching between different FIFO buffer operating modes.

As described in the next figure, for each channel only the first address is used. When new data is available, the older data is overwritten.

**Figure 8. Bypass mode**



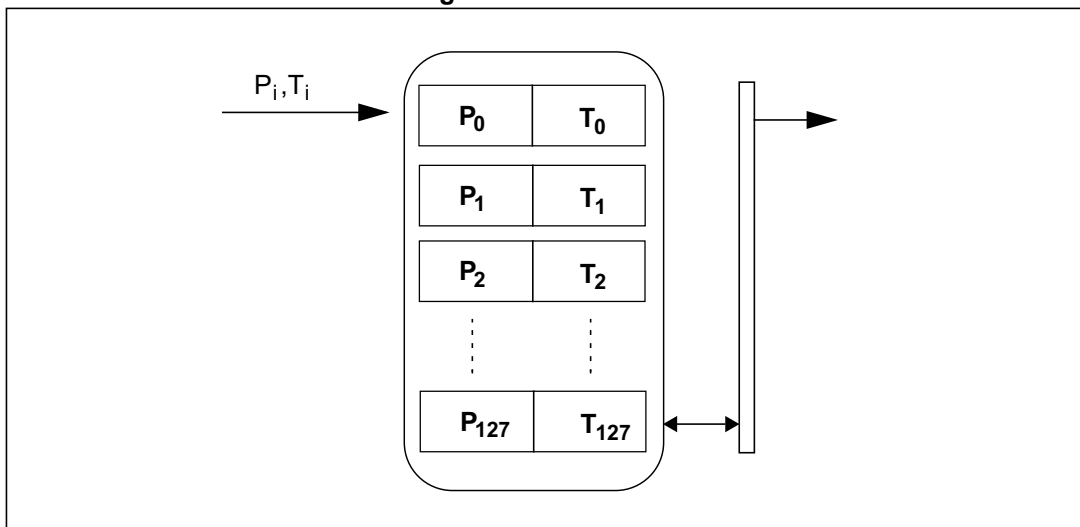
## 5.2 FIFO mode

In FIFO mode (*FIFO\_CTRL (13h)*(TRIG\_MODES and F\_MODE[1:0] = '001') data from the output *PRESS\_OUT\_XL (28h)*, *PRESS\_OUT\_L (29h)*, *PRESS\_OUT\_H (2Ah)*, *TEMP\_OUT\_L (2Bh)*, and *TEMP\_OUT\_H (2Ch)* are stored in the FIFO until it is full.

To reset FIFO content, in order to select Bypass mode the value '000' must be written in *FIFO\_CTRL (13h)*(TRIG\_MODE & F\_MODE[1:0]). After this reset command it is possible to restart FIFO mode by writing the value '001' in *FIFO\_CTRL (13h)*(TRIG\_MODE & F\_MODE[1:0]).

The FIFO buffer memorizes 128 levels of data, but the depth of the FIFO can be resized/reduced by setting the *FIFO\_CTRL (13h)*(STOP\_ON\_WTM) bit. If the STOP\_ON\_WTM bit is set to '1', FIFO depth is limited to *FIFO\_WTM (14h)*(WTM[6:0]) data.

Figure 9. FIFO mode



### 5.3 Continuous (Dynamic-Stream) mode

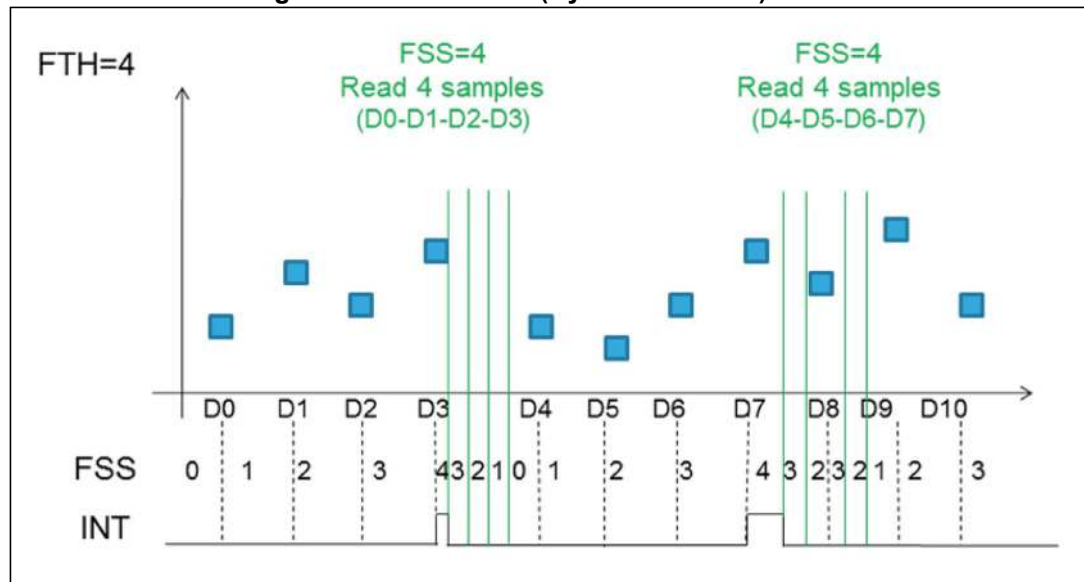
In Continuous (Dynamic-Stream) mode (*FIFO\_CTRL (13h)*(TRIG\_MODES and F\_MODE[1:0] = '011') after emptying the FIFO, the first new sample that arrives becomes the first to be read in a subsequent read burst. In this way, the number of new data available in FIFO does not depend on the previous read.

In Continuous (Dynamic-Stream) mode *FIFO\_STATUS1 (25h)*(FSS[7:0]) is the number of new pressure and temperature samples available in the FIFO buffer.

Continuous (Dynamic-Stream) is intended to be used to read *FIFO\_STATUS1 (25h)*(FSS[7:0]) samples when it is not possible to guarantee reading data within 1/ODR time period.

Also, a FIFO threshold interrupt on the INT\_DRDY pad through *CTRL\_REG3 (12h)*(INT\_F\_WTM) can be enabled in order to read data from the FIFO and leave free memory slots for incoming data.

Figure 10. Continuous (Dynamic-Stream) mode

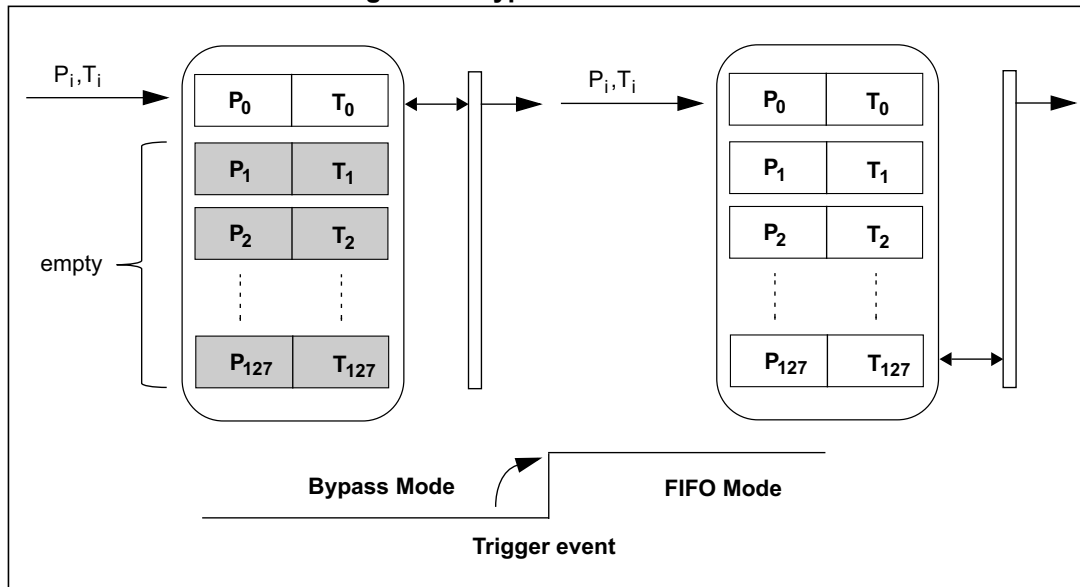


## 5.4 Bypass-to-FIFO mode

In Bypass-to-FIFO mode (*FIFO\_CTRL (13h)*(TRIG\_MODES and F\_MODE[1:0] = '101'), FIFO behavior switches when the *INT\_SOURCE (24h)*(IA) bit rises for the first time. When the *INT\_SOURCE (24h)*(IA) bit is equal to '0', FIFO behaves like in Bypass mode. Once the *INT\_SOURCE (24h)*(IA) bit rises to '1', FIFO behavior switches and keeps behaving like in FIFO mode.

An interrupt generator has to be set to the desired configuration through *INTERRUPT\_CFG (0Bh)*.

Figure 11. Bypass-to-FIFO mode

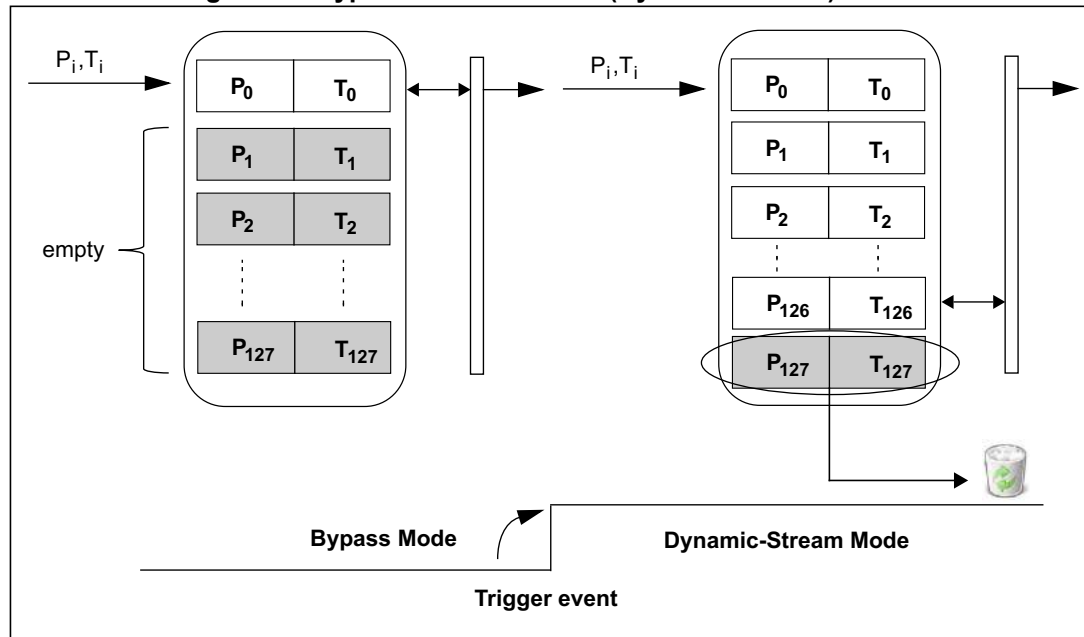


### 5.5 Bypass-to-Continuous (Dynamic-Stream) mode

In Bypass-to-Continuous (Dynamic-Stream) mode (*FIFO\_CTRL (13h)*(TRIG\_MODES and F\_MODE[1:0] = '110'), FIFO operates in Bypass mode until it switches to Continuous (Dynamic-Stream) mode behavior when *INT\_SOURCE (24h)*(IA) rises to '1', then FIFO behavior keeps behaving like in Continuous (Dynamic-Stream) mode.

An interrupt generator has to be set to the desired configuration through *INTERRUPT\_CFG (0Bh)*.

Figure 12. Bypass-to-Continuous (Dynamic-Stream) mode

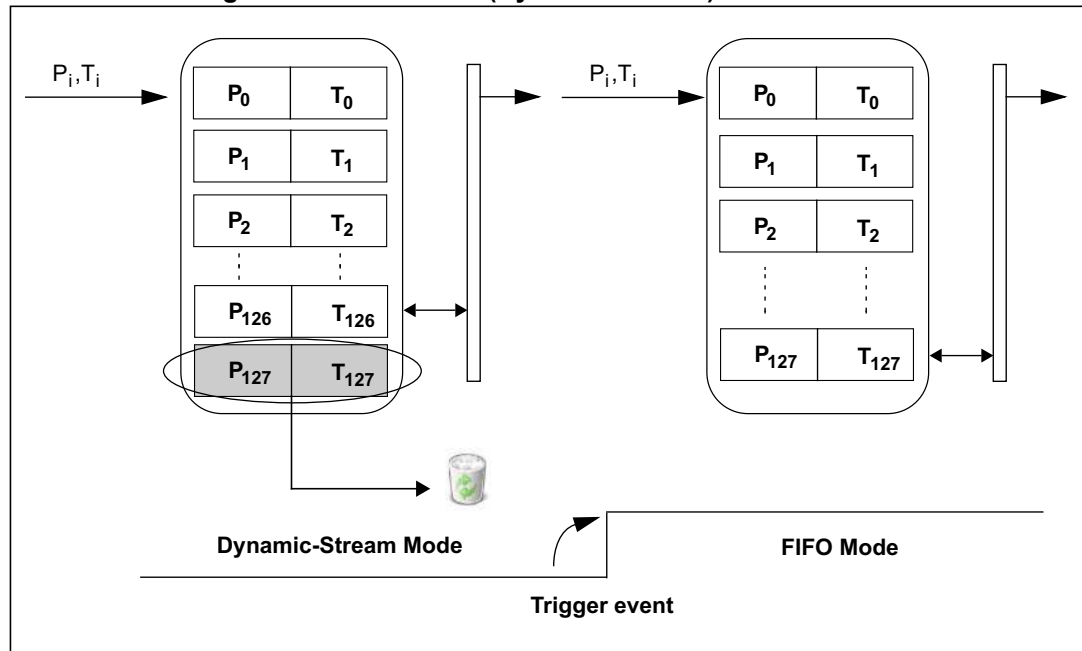


## 5.6 Continuous (Dynamic-Stream)-to-FIFO mode

In Continuous (Dynamic-Stream)-to-FIFO mode (*FIFO\_CTRL (13h)*(TRIG\_MODES and F\_MODE[1:0] = '111'), data are stored in FIFO and FIFO operates in Continuous (Dynamic-Stream) mode behavior until it switches to FIFO mode behavior when *INT\_SOURCE (24h)*(IA) rises to '1'.

An interrupt generator has to be set to the desired configuration through *INTERRUPT\_CFG (0Bh)*.

Figure 13. Continuous (Dynamic-Stream)-to-FIFO mode



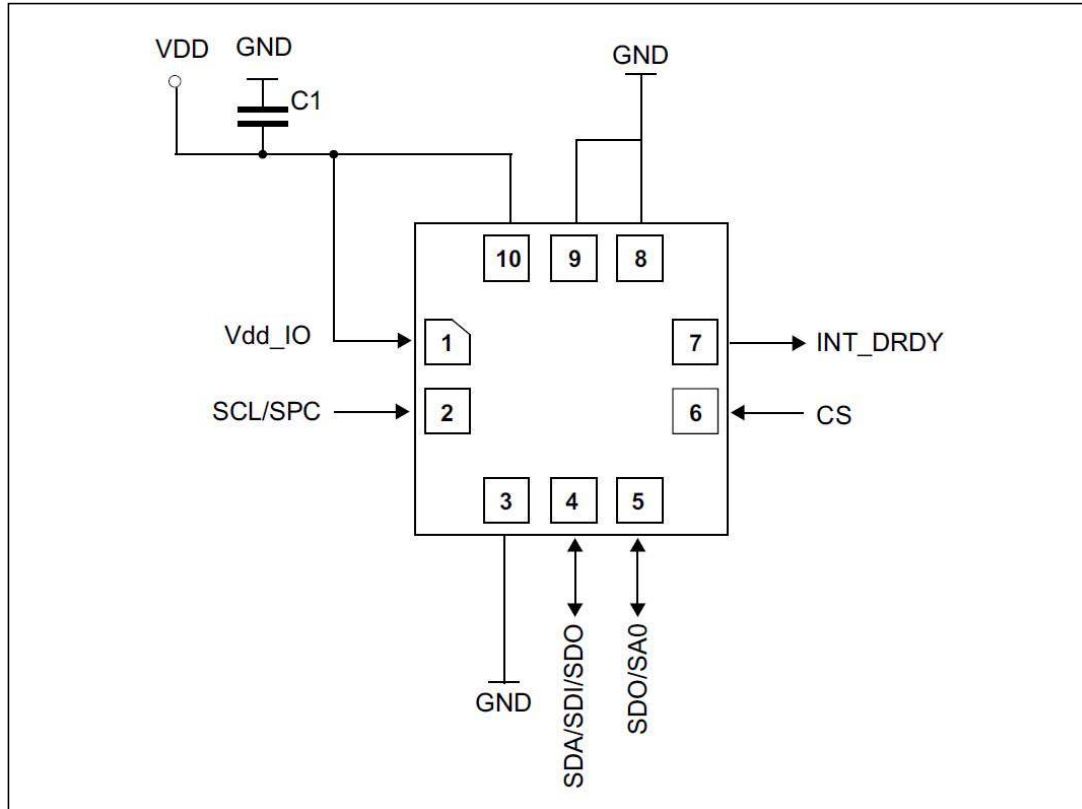
## 5.7 Retrieving data from FIFO

FIFO data is read through *FIFO\_DATA\_OUT\_PRESS (78h, 79h and 7Ah)* and *FIFO\_DATA\_OUT\_TEMP (7Bh, 7Ch)*.

The read address is automatically updated by the device and it rolls back to 78h when register 7Ch is reached. In order to read all FIFO levels in a multiple byte read, 640 bytes (5 output registers by 128 levels) must be read.

## 6 Application hints

Figure 14. LPS22CH electrical connections (top view)



The device power supply must be provided through the VDD line; a power supply decoupling capacitor C1 (100 nF) must be placed as near as possible to the supply pads of the device. The C1 capacitor can be tied to VDD and VDDIO, but it is recommended to use 2 capacitors, one on each VDD and VDDIO line, in case VDD and VDDIO are separate. Depending on the application, an additional capacitor of 4.7  $\mu$ F could be placed on the VDD line.

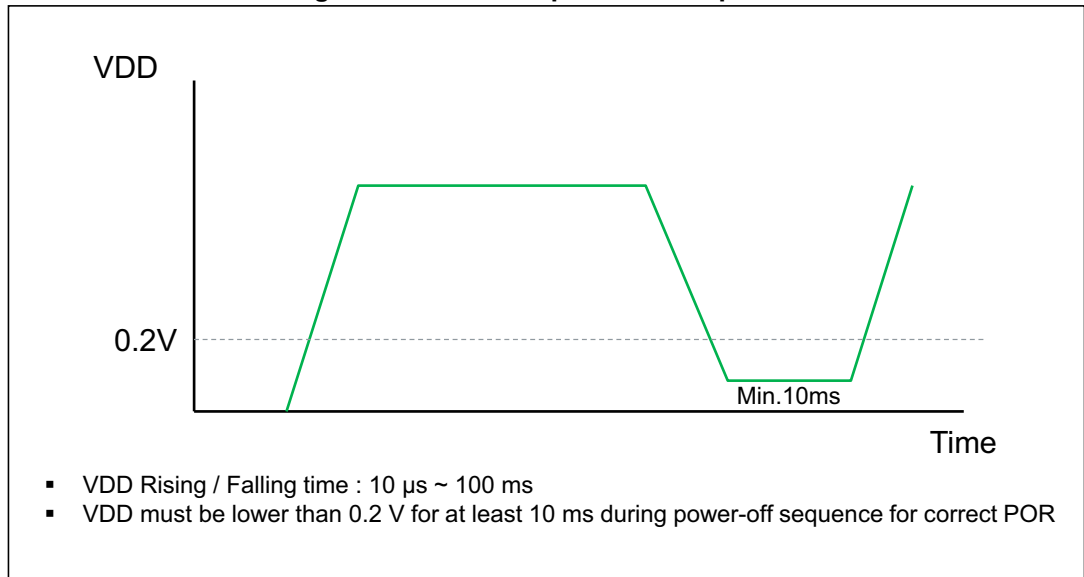
The functionality of the device and the measured data outputs are selectable and accessible through the I<sup>2</sup>C, SPI interface. When using the I<sup>2</sup>C, CS must be tied to Vdd\_IO.

All the voltage and ground supplies must be present at the same time to have proper behavior of the IC (refer to [Figure 14](#)). It is possible to remove VDD while maintaining Vdd\_IO without blocking the communication bus, in this condition the measurement chain is powered off.

**Note:** *To guarantee proper power-off of the device, it is recommended to maintain the duration of the VDD line to GND for at least 10 ms.*



Figure 15. LPS22CH power-off sequence



## 6.1 Soldering information

The HLGA package is compliant with the ECOPACK standard and it is qualified for soldering heat resistance according to JEDEC J-STD-020.

## 7 Digital interfaces

### 7.1 Serial interfaces

The registers embedded in the LPS22CH may be accessed through either the I<sup>2</sup>C or SPI serial interfaces. The latter may be SW configured to operate either in 3-wire or 4-wire interface mode.

The serial interfaces are mapped onto the same pads. To select/exploit the I<sup>2</sup>C interface, the CS line must be tied high (i.e. connected to Vdd\_IO).

**Table 9. Serial interface pin description**

Pin name	Pin description
CS	SPI enable I <sup>2</sup> C/SPI mode selection (1: SPI idle mode / I <sup>2</sup> C communication enabled; 0: SPI communication mode / I <sup>2</sup> C disabled)
SCL/SPC	I <sup>2</sup> C serial clock (SCL) SPI serial port clock (SPC)
SDA SDI SDI/SDO	I <sup>2</sup> C serial data (SDA) 4-wire SPI serial data input (SDI) 3-wire serial data input /output (SDI/SDO)
SDO SAO	4-wire SPI serial data output (SDO) I <sup>2</sup> C less significant bit of the device address (SA0)

### 7.2 I<sup>2</sup>C serial interface (CS = high)

The LPS22CH I<sup>2</sup>C is a bus slave. The I<sup>2</sup>C is employed to write data into registers whose content can also be read back.

The relevant I<sup>2</sup>C terminology is given in [Table 10](#).

**Table 10. I<sup>2</sup>C terminology**

Term	Description
Transmitter	The device which sends data to the bus
Receiver	The device which receives data from the bus
Master	The device which initiates a transfer, generates clock signals and terminates a transfer
Slave	The device addressed by the master

There are two signals associated with the I<sup>2</sup>C bus: the serial clock line (SCL) and the serial data line (SDA). The latter is a bidirectional line used for sending and receiving the data to/from the interface. Both lines have to be connected to Vdd\_IO through pull-up resistors.

The I<sup>2</sup>C interface is compliant with fast mode (400 kHz) I<sup>2</sup>C standards as well as with the normal mode.

### 7.2.1 I<sup>2</sup>C operation

The transaction on the bus is started through a START (ST) signal. A start condition is defined as a HIGH-to-LOW transition on the data line while the SCL line is held HIGH. After the master has transmitted this, the bus is considered busy. The next data byte transmitted after the start condition contains the address of the slave in the first 7 bits and the eighth bit tells whether the master is receiving data from the slave or transmitting data to the slave. When an address is sent, each device in the system compares the first seven bits after a start condition with its address. If they match, the device considers itself addressed by the master.

The 7-bit slave address (SAD) associated to the LPS22CH is 101110xb. The **SDO/SA0** pad can be used to modify the less significant bit of the device address. If the SA0 pad is connected to voltage supply, LSb is '1' (7-bit address 1011101b=5Dh), otherwise if the SA0 pad is connected to ground, the LSb value is '0' (7-bit address 1011100b=5Ch). This solution permits connecting and addressing two different LPS22CH devices to the same I<sup>2</sup>C lines.

Data transfer with acknowledge is mandatory. The transmitter must release the SDA line during the acknowledge pulse. The receiver must then pull the data line LOW so that it remains stable low during the HIGH period of the acknowledge clock pulse. A receiver which has been addressed is obliged to generate an acknowledge after each byte of data received.

The I<sup>2</sup>C embedded inside the ASIC behaves like a slave device and the following protocol must be adhered to. After the start condition (ST) a slave address is sent, once a slave acknowledge has been returned (SAK), an 8-bit sub-address will be transmitted (SUB): the 7 LSB represent the actual register address while the MSB has no meaning. The IF\_ADD\_INC bit in [CTRL\\_REG2 \(11h\)](#) enables sub-address auto increment (IF\_ADD\_INC is '1' by default), so if IF\_ADD\_INC = '1' the SUB (sub-address) will be automatically increased to allow multiple data read/write.

The slave address is completed with a Read/Write bit. If the bit is '1' (Read), a repeated START (SR) condition must be issued after the two sub-address bytes; if the bit is '0' (Write) the master will transmit to the slave with direction unchanged. [Table 11](#) explains how the SAD+read/write bit pattern is composed, listing all the possible configurations.

**Table 11. SAD+Read/Write patterns**

Command	SAD[6:1]	SAD[0] = SA0	R/W	SAD+R/W
Read	101110	0	1	10111001 (B9h)
Write	101110	0	0	10111000 (B8h)
Read	101110	1	1	10111011 (BBh)
Write	101110	1	0	10111010 (BAh)

**Table 12. Transfer when master is writing one byte to slave**

Master	ST	SAD + W		SUB		DATA		SP
Slave			SAK		SAK		SAK	

**Table 13. Transfer when master is writing multiple bytes to slave**

Master	ST	SAD + W		SUB		DATA		DATA		SP
Slave			SAK		SAK		SAK		SAK	

**Table 14. Transfer when master is receiving (reading) one byte of data from slave**

Master	ST	SAD + W		SUB		SR	SAD + R			NMAK	SP
Slave			SAK		SAK			SAK	DATA		

**Table 15. Transfer when master is receiving (reading) multiple bytes of data from slave**

Master	ST	SAD+W		SUB		SR	SAD+R			MAK		MAK		NMAK	SP
Slave			SAK		SAK			SAK	DATA		DATA		DATA		

Data are transmitted in byte format (DATA). Each data transfer contains 8 bits. The number of bytes transferred per transfer is unlimited. Data is transferred with the most significant bit (MSb) first. If a slave receiver does not acknowledge the slave address (i.e. it is not able to receive because it is performing some real-time function), the data line must be kept HIGH by the slave. The master can then abort the transfer. A LOW-to-HIGH transition on the SDA line while the SCL line is HIGH is defined as a STOP condition. Each data transfer must be terminated by the generation of a STOP (SP) condition.

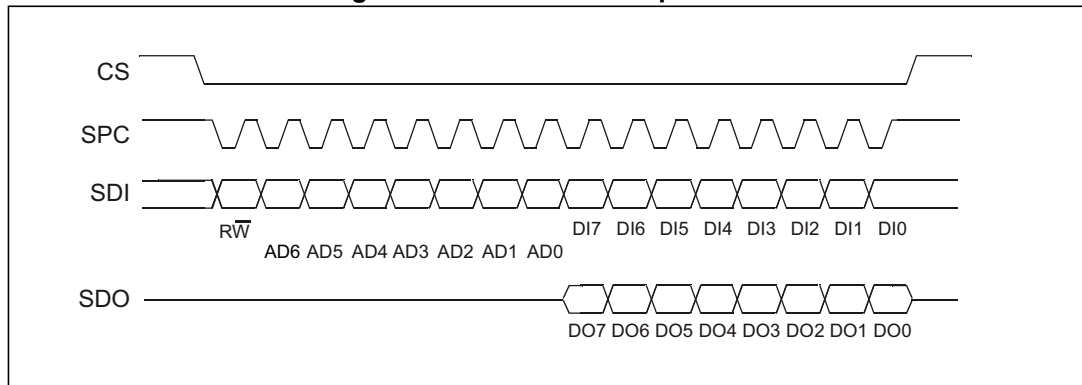
In the presented communication format MAK is Master acknowledge and NMAK is no master acknowledge.

### 7.3 SPI bus interface (CS = low)

The LPS22CH SPI is a bus slave. The SPI allows writing to and reading from the registers of the device.

The serial interface interacts with the application using 4 wires: **CS**, **SPC**, **SDI** and **SDO**.

**Figure 16. Read and write protocol**



**CS** is the serial port enable and it is controlled by the SPI master. It goes low at the start of the transmission and returns to high at the end. **SPC** is the serial port clock and it is controlled by the SPI master. It is stopped high when **CS** is high (no transmission). **SDI** and **SDO** are respectively the serial port data input and output. Those lines are driven at the falling edge of **SPC** and should be captured at the rising edge of **SPC**.

Both the read register and write register commands are completed in 16 clock pulses or multiples of 8 in the case of multiple read/write bytes. Bit duration is the time between two falling edges of **SPC**. The first bit (bit 0) starts at the first falling edge of **SPC** after the falling edge of **CS** while the last bit (bit 15, bit 23,...) starts at the last falling edge of **SPC** just before the rising edge of **CS**.

**bit 0:**  $R\bar{W}$  bit. When 0, the data  $DI(7:0)$  is written into the device. When 1, the data  $DO(7:0)$  from the device is read. In the latter case, the chip will drive **SDO** at the start of bit 8.

**bit 1-7:** address  $AD(6:0)$ . This is the address field of the indexed register.

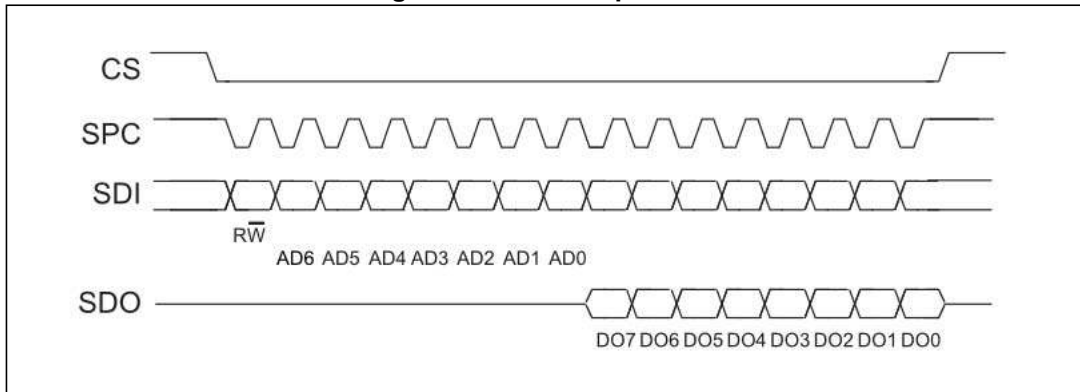
**bit 8-15:** data  $DI(7:0)$  (write mode). This is the data that is written into the device (MSb first).

**bit 8-15:** data  $DO(7:0)$  (read mode). This is the data that is read from the device (MSb first). In multiple read/write commands further blocks of 8 clock periods are added. When the  $IF\_ADD\_INC$  bit is 0, the address used to read/write data remains the same for every block. When the  $IF\_ADD\_INC$  bit is 1, the address used to read/write data is incremented at every block.

The function and the behavior of **SDI** and **SDO** remain unchanged.

### 7.3.1 SPI read

Figure 17. SPI read protocol



The SPI read command is performed with 16 clock pulses. The multiple byte read command is performed by adding blocks of 8 clock pulses to the previous one.

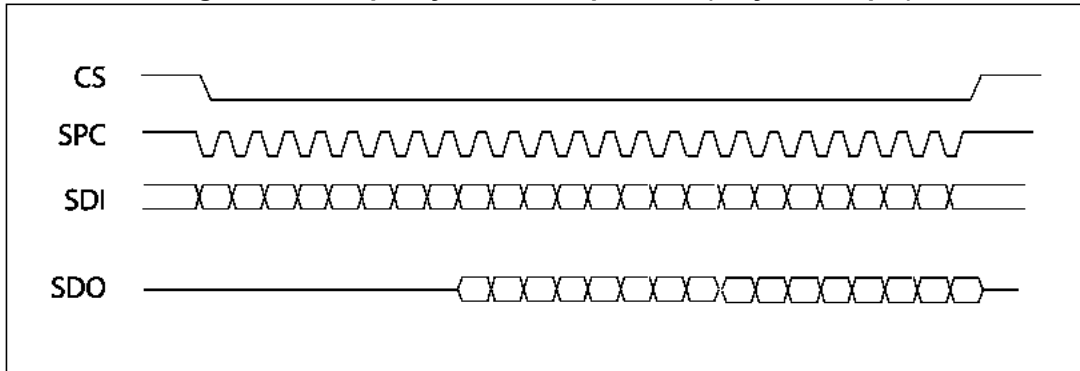
**bit 0:** READ bit. The value is 1.

**bit 1-7:** address AD(6:0). This is the address field of the indexed register.

**bit 8-15:** data DO(7:0) (read mode). This is the data that is read from the device (MSb first).

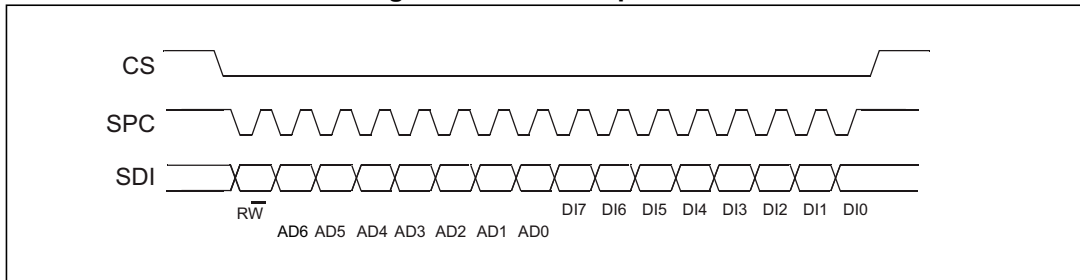
**bit 16-...:** data DO(...-8). Further data in multiple byte reads.

Figure 18. Multiple byte SPI read protocol (2-byte example)



### 7.3.2 SPI write

Figure 19. SPI write protocol



The SPI write command is performed with 16 clock pulses. The multiple byte write command is performed by adding blocks of 8 clock pulses to the previous one.

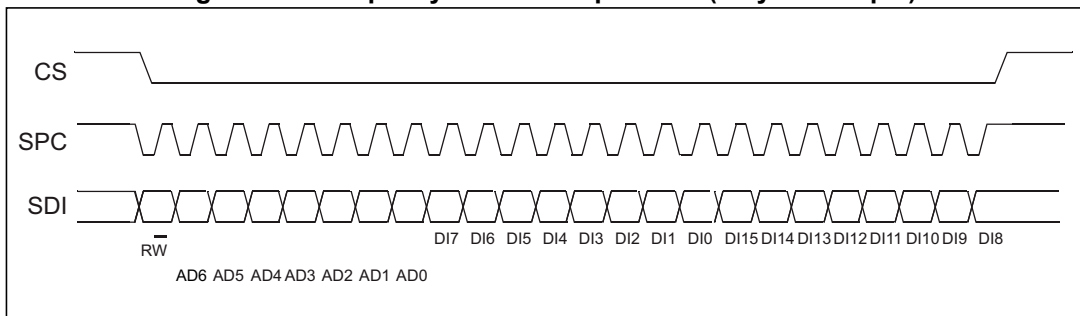
**bit 0:** WRITE bit. The value is 0.

**bit 1-7:** address AD(6:0). This is the address field of the indexed register.

**bit 8-15:** data DI(7:0) (write mode). This is the data that is written in the device (MSb first).

**bit 16-...:** data DI(...-8). Further data in multiple byte writes.

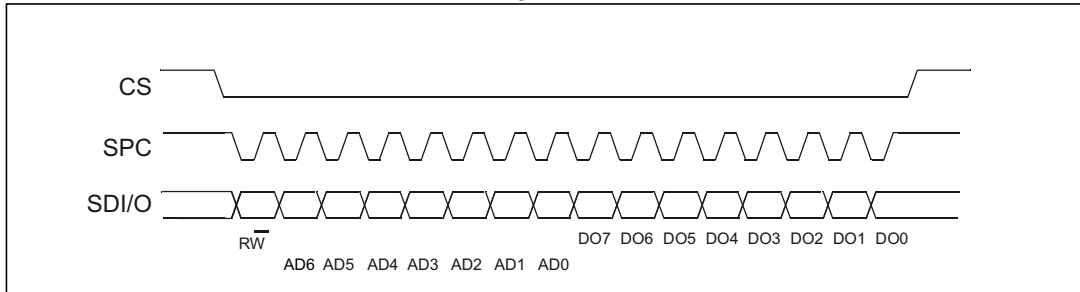
Figure 20. Multiple byte SPI write protocol (2-byte example)



### 7.3.3 SPI read in 3-wire mode

A 3-wire mode is entered by setting bit SIM to '1' (SPI serial interface mode selection) in *CTRL\_REG1 (10h)*.

Figure 21. SPI read protocol in 3-wire mode



The SPI read command is performed with 16 clock pulses:

**bit 0:** READ bit. The value is 1.

**bit 1-7:** address AD(6:0). This is the address field of the indexed register.

**bit 8-15:** data DO(7:0) (read mode). This is the data that is read from the device (MSb first).  
A multiple read command is also available in 3-wire mode.



## 8 Register mapping

Table 16 provides a quick overview of the 8-bit registers embedded in the device.

**Table 16. Registers address map**

Name	Type	Register address	Default	Function and comment
		Hex	Binary	
Reserved		00 – 0A	-	Reserved
INTERRUPT_CFG	R/W	0B	00000000	Interrupt register
THS_P_L	R/W	0C	00000000	Pressure threshold registers
THS_P_H	R/W	0D	00000000	
IF_CTRL	R/W	0E	00000000	Interface control register
WHO_AM_I	R	0F	10110011	Who am I
CTRL_REG1	R/W	10	00000000	Control registers
CTRL_REG2	R/W	11	00010000	
CTRL_REG3	R/W	12	00000000	
FIFO_CTRL	R/W	13	00000000	FIFO configuration register
FIFO_WTM	R/W	14	00000000	
REF_P_L	R	15	00000000	Reference pressure registers
REF_P_H	R	16	00000000	
Reserved		17	-	Reserved
RPDS_L	R/W	18	00000000	Pressure offset registers
RPDS_H	R/W	19	00000000	
Reserved		1A-23	-	Reserved
INT_SOURCE	R	24	Output	Interrupt register
FIFO_STATUS1	R	25	Output	FIFO status registers
FIFO_STATUS2	R	26	Output	
STATUS	R	27	Output	Status register
PRESSURE_OUT_XL	R	28	Output	Pressure output registers
PRESSURE_OUT_L	R	29	Output	
PRESSURE_OUT_H	R	2A	Output	
TEMP_OUT_L	R	2B	Output	Temperature output registers
TEMP_OUT_H	R	2C	Output	
Reserved		2D - 77	-	Reserved
FIFO_DATA_OUT_PRESS_XL	R	78	Output	FIFO pressure output registers
FIFO_DATA_OUT_PRESS_L	R	79	Output	
FIFO_DATA_OUT_PRESS_H	R	7A	Output	

Table 16. Registers address map (continued)

Name	Type	Register address	Default	Function and comment
		Hex	Binary	
FIFO_DATA_OUT_TEMP_L	R	7B	Output	FIFO temperature output registers
FIFO_DATA_OUT_TEMP_H	R	7C	Output	

Registers marked as Reserved must not be changed. Writing to those registers may cause permanent damage to the device.

To guarantee the proper behavior of the device, all register addresses not listed in the above table must not be accessed and the content stored in those registers must not be changed.

The content of the registers that are loaded at boot should not be changed. They contain the factory calibration values. Their content is automatically restored when the device is powered up.

## 9 Register description

The device contains a set of registers which are used to control its behavior and to retrieve pressure and temperature data. The register address, made up of 7 bits, is used to identify them and to read/write the data through the serial interface.

### 9.1 INTERRUPT\_CFG (0Bh)

Interrupt mode for pressure acquisition configuration (R/W)

7	6	5	4	3	2	1	0
AUTOREFP	RESET_ARP	AUTOZERO	RESET_AZ	DIFF_EN	LIR	PLE	PHE
AUTOREFP	Enable AUTOREFP function. Default value: 0 (0: normal mode; 1: AUTOREFP enabled)						
RESET_ARP	Reset AUTOREFP function. Default value: 0 (0: normal mode; 1: reset AUTOREFP function)						
AUTOZERO	Enable AUTOZERO function. Default value: 0 (0: normal mode; 1: AUTOZERO enabled)						
RESET_AZ	Reset AUTOZERO function. Default value: 0 (0: normal mode; 1: reset AUTOZERO function)						
DIFF_EN	Enable interrupt generation. Default value: 0 (0: interrupt generation disabled; 1: interrupt generation enabled)						
LIR	Latch interrupt request to the <i>INT_SOURCE (24h)</i> register. Default value: 0 (0: interrupt request not latched; 1: interrupt request latched)						
PLE	Enable interrupt generation on pressure low event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on pressure value lower than preset threshold)						
PHE	Enable interrupt generation on pressure high event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on pressure value higher than preset threshold)						

Referring to *Figure 22: "Threshold-based" interrupt event*, the LPS22CH can be set by the user to support the interrupt function when P\_DIFF\_IN (defined below) is higher or lower than the threshold value stored in *THS\_P\_L (0Ch)* and *THS\_P\_H (0Dh)*.

It is enabled when the DIFF\_EN bit in *INTERRUPT\_CFG (0Bh)* register is set to '1' and either PHE bit or PLE bit (or both bits) = '1'. Then, the differential pressure can be compared to a user-defined threshold stored in the 15-bit THS\_P (0Ch and 0Dh) registers.

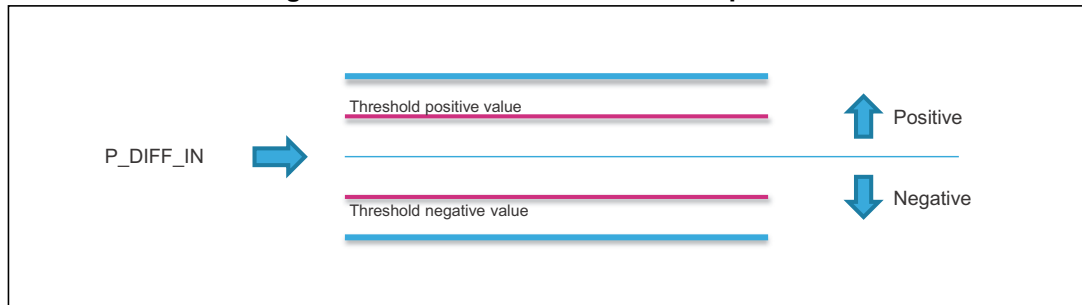
The threshold pressure value defined by the user is a 15-bit unsigned value in a 16-bit register composed of *THS\_P\_L (0Ch)* and *THS\_P\_H (0Dh)*. The value is:

$$\text{THS\_P (15-bit unsigned)} = \text{Desired Interrupt threshold (hPa)} \times 16$$

The PHE and PLE bits in *INTERRUPT\_CFG (0Bh)* enable the differential pressure interrupt generation on the positive or negative event respectively.

The differential interrupt must be used with AUTOREFP or AUTOZERO mode. Please refer to the application note (AN5209: Section 8. Interrupt modes) for further details.

Figure 22. "Threshold-based" interrupt event



To enable the **AUTOZERO** mode, the **AUTOZERO** bit must be set to '1' and then the measured pressure value is used as the reference and stored in the register **REF\_P** (**REF\_P\_L (15h)**, **REF\_P\_H (16h)**). From this point on, the output pressure value (**PRESS\_OUT\_XL (28h)**, **PRESS\_OUT\_L (29h)**, **PRESS\_OUT\_H (2Ah)**) is updated with the difference between the measured pressure and **REF\_P**.

- $P\_DIFF\_IN = \text{measured pressure} - REF\_P$
- $PRESS\_OUT = \text{measured pressure} - REF\_P$

After the first conversion, the **AUTOZERO** bit is automatically set back to '0'. In order to return back to normal mode, the **RESET\_AZ** bit in the **INTERRUPT\_CFG (0Bh)** register has to be set to '1'. This also resets the content of the **REF\_P** registers to 0.

**AUTOREFP** mode allows using the pressure differential for the generation of the interrupt keeping the output pressure registers **PRESS\_OUT** (**PRESS\_OUT\_XL (28h)**, **PRESS\_OUT\_L (29h)**, **PRESS\_OUT\_H (2Ah)**) without comparing **REF\_P**. If the **AUTOREFP** bit is set to '1', the measured output pressure is used as the reference in the register **REF\_P** (**REF\_P\_L (15h)**, **REF\_P\_H (16h)**) for interrupt generation with following:

- $P\_DIFF\_IN = \text{measured pressure} - REF\_P$

The output registers **PRESS\_OUT** (28h, 29h and 2Ah) are not changed by **REF\_P** and shows as follows.

- $PRESS\_OUT = \text{measured pressure}$

After the first conversion, the **AUTOREFP** bit is automatically set to '0'. In order to return back to normal mode, the **RESET\_ARP** bit has to be set to '1'

## 9.2 THS\_P\_L (0Ch)

User-defined threshold value for pressure interrupt event (Least significant bits) (R/W)

7	6	5	4	3	2	1	0
THS7	THS6	THS5	THS4	THS3	THS2	THS1	THS0

THS[7:0]	This register contains the low part of threshold value for pressure interrupt generation. Default value: 00h
----------	---

The threshold value for pressure interrupt generation is a 15-bit unsigned right-justified value composed of [THS\\_P\\_H \(0Dh\)](#) and [THS\\_P\\_L \(0Ch\)](#). The value is expressed as:

$THS\_P$  (15-bit unsigned) = Desired interrupt threshold (hPa) x 16

To enable the interrupt event based on this user-defined threshold, the DIFF\_EN bit in [INTERRUPT\\_CFG \(0Bh\)](#) must be set to '1', the PHE bit or PLE bit (or both bits) in [INTERRUPT\\_CFG \(0Bh\)](#) has to be enabled.

## 9.3 THS\_P\_H (0Dh)

User-defined threshold value for pressure interrupt event (Most significant bits) (R/W)

7	6	5	4	3	2	1	0
-	THS14	THS13	THS12	THS11	THS10	THS9	THS8

THS[14:8]	This register contains the high part of threshold value for pressure interrupt generation. Refer to <a href="#">THS_P_L (0Ch)</a> . Default value: 00h
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## 9.4 IF\_CTRL (0Eh)

Interface control register (R/W)

7	6	5	4	3	2	1	0
0	0	0	SDA_PU_EN	SDO_PU_EN	PD_DIS_INT1	0	I2C_DISABLE

SDA_PU_EN	Enable pull-up on the SDA pin. Default value: 0 (0: SDA pin pull-up disconnected; 1: SDA pin with pull-up)
SDO_PU_EN	Enable pull-up on the SDO pin. Default value: 0 (0: SDO pin pull-up disconnected; 1: SDO pin with pull-up)
PD_DIS_INT1	Disable pull down on the INT1 pin. Default value: 0 (0: INT1 pin with pull-down; 1: INT1 pin pull-down disconnected)
I2C_DISABLE <sup>(1)</sup>	Disable I <sup>2</sup> C interface. Default value: 0 (0: I <sup>2</sup> C enabled; 1: I <sup>2</sup> C disabled)

1. I2C\_DISABLE bit disables the I<sup>2</sup>C interface, by default both SPI and I<sup>2</sup>C interfaces are enabled.

## 9.5 WHO\_AM\_I (0Fh)

Device Who am I

7	6	5	4	3	2	1	0
1	0	1	1	0	0	1	1

## 9.6 CTRL\_REG1 (10h)

Control register 1 (R/W)

7	6	5	4	3	2	1	0
0	ODR2	ODR1	ODR0	EN_LPFP	LPFP_CFG	BDU	SIM

ODR[2:0]	Output data rate selection. Default value: 000 Refer to <a href="#">Table 17</a> .
EN_LPFP	Enable low-pass filter on pressure data when Continuous mode is used. Default value: 0 (0: Low-pass filter disabled; 1: Low-pass filter enabled)
LPFP_CFG	LPFP_CFG: Low-pass configuration register. Default value: 0 Refer to <a href="#">Table 18</a> .
BDU <sup>(1)</sup>	Block data update. Default value: 0 (0: continuous update; 1: output registers not updated until MSB and LSB have been read)
SIM	SPI Serial Interface Mode selection. Default value: 0 (0: 4-wire interface; 1: 3-wire interface)

1. To guarantee the correct behavior of BDU feature, [PRESS\\_OUT\\_H \(2Ah\)](#) must be the last address read.

**Table 17. Output data rate bit configurations**

ODR[2:0]	Temperature, Pressure
000	One-shot
001	1 Hz
010	10 Hz
011	25 Hz
100	50 Hz
101	75 Hz
110 <sup>(1)</sup>	100 Hz
111 <sup>(1)</sup>	200 Hz

1. This option disables the low-noise mode automatically.

When the ODR bits are set to '000', the device is in **Power-down mode**. When the device is in power-down mode, almost all internal blocks of the device are switched off to minimize power consumption. The I<sup>2</sup>C interface is still active to allow communication with the device. The content of the configuration registers is preserved and output data registers are not updated, therefore keeping the last data sampled in memory before going into power-down mode.

If the ONE\_SHOT bit in [CTRL\\_REG2 \(11h\)](#) is set to '1', **One-shot mode** is triggered and a new acquisition starts when it is required. Enabling this mode is possible only if the device was previously in power-down mode (ODR bits set to '000'). Once the acquisition is completed and the output registers updated, the device automatically enters in power-down mode. ONE\_SHOT bit self-clears itself.

When the ODR bits are set to a value different than '000', the device is in **Continuous mode** and automatically acquires a set of data (pressure and temperature) at the frequency selected through the ODR[2:0] bits.

Once the additional low-pass filter has been enabled through the EN\_LPFP bit, it is possible to configure the device bandwidth acting on the LPFP\_CFG bit. See [Table 18](#) for low-pass filter configurations.

**Table 18. Low-pass filter configurations**

EN_LPFP	LPFP_CFG	Additional low-pass filter status	Device bandwidth
0	x	Disabled	ODR/2
1	0	Enabled	ODR/9
1	1	Enabled	ODR/20

The BDU bit is used to inhibit the update of the output registers until both upper and lower (and XLOW) register parts are read. In default mode (BDU = '0') the output register values are updated continuously. If for any reason it is not sure to read faster than the output data rate, it is recommended to set the BDU bit to '1'. In this way, the content of the output registers is not updated until MSB, LSB and XLSB have been read which avoids reading values related to different sample times.



## 9.7 CTRL\_REG2 (11h)

Control register 2 (R/W)

7	6	5	4	3	2	1	0
BOOT	INT_H_L	PP_OD	IF_ADD_INC	0	SWRESET	LOW_NOISE_EN	ONE_SHOT
BOOT	Reboots memory content. Default value: 0 (0: normal mode; 1: reboot memory content)						
INT_H_L	Interrupt active-high, active-low. Default value: 0 (0: active high; 1: active low)						
PP_OD	Push-pull/open-drain selection on interrupt pad. Default value: 0 (0: push-pull; 1: open-drain)						
IF_ADD_INC	Register address automatically incremented during a multiple byte access with a serial interface (I <sup>2</sup> C or SPI). Default value: 1 (0: disable; 1: enable)						
SWRESET	Software reset. Default value: 0 (0: normal mode; 1: software reset). The bit is self-cleared when the reset is completed.						
LOW_NOISE_EN	Enables low noise (used only if ODR is lower than 100 Hz). Default value: 0 (0: low-current mode; 1: low-noise mode)						
ONE_SHOT	Enables one-shot. Default value: 0 (0: idle mode; 1: a new dataset is acquired)						

The BOOT bit is used to refresh the content of the internal registers stored in the Flash memory block. At device power-up, the content of the Flash memory block is transferred to the internal registers related to the trimming functions to allow correct behavior of the device itself. If for any reason the content of the trimming registers is modified, it is sufficient to use this bit to restore the correct values. When the BOOT bit is set to '1', the content of the internal Flash is copied into the corresponding internal registers and is used to calibrate the device. These values are factory trimmed and they are different for every device. They allow the correct behavior of the device and normally they should not be changed. At the end of the boot process, the BOOT bit is set again to '0' by hardware. The BOOT bit takes effect immediately after it is set to 1.

INT\_H\_L selects an interrupt active-high/low value.

PP\_OD selects push-pull/open-drain on the interrupt pad.

The IF\_ADD\_INC bit enables the address to be automatically incremented during a multiple byte access with a serial interface (SPI or I<sup>2</sup>C).

The SWRESET bit resets the volatile registers to default value '0'. It returns to '0' by hardware.

LOW\_NOISE\_EN is disabled by default and must be changed when the device is in power-down mode. It enables low-noise mode but can be used when the ODR is lower than 100 Hz. If ODR = 100 Hz or ODR = 200 Hz, this option is automatically switched off and the value of the low-noise enable bit is ignored.

LOW\_NOISE\_EN mode is enabled to have less RMS noise and the best performance is achieved with LOW\_NOISE\_EN set to 1 and filter at ODR/20. Depending on the application, the LOW\_NOISE\_EN bit can be enabled (low-noise mode) or disabled (low-current mode) to have less RMS noise or less power consumption (refer to the following table).

**Table 19. RMS noise and power consumption**

Mode	Additional low-pass filter status	Device bandwidth	RMS noise [Pa]	Supply current @ ODR = 1 Hz [ $\mu$ A]
Low noise	Disabled		2	12
	Enabled	ODR/9	1.1	12
	Enabled	ODR/20	0.75	12
Low current	Disabled		4.9	4
	Enabled	ODR/9	2.9	4
	Enabled	ODR/20	2	4

The ONE\_SHOT bit is used to start a new conversion when the ODR[2:0] bits in [CTRL\\_REG1 \(10h\)](#) are set to '000'. Writing a '1' in ONE\_SHOT triggers a single measurement of pressure and temperature. Once the measurement is done, the ONE\_SHOT bit will self-clear, the new data are available in the output registers, and the [STATUS \(27h\)](#) bits are updated.

### 9.8 CTRL\_REG3 (12h)

Control register 3 - INT\_DRDY pin control register (R/W)

7	6	5	4	3	2	1	0
0	0	INT_F_FULL	INT_F_WTM	INT_F_OVR	DRDY	INT_S1	INT_S0

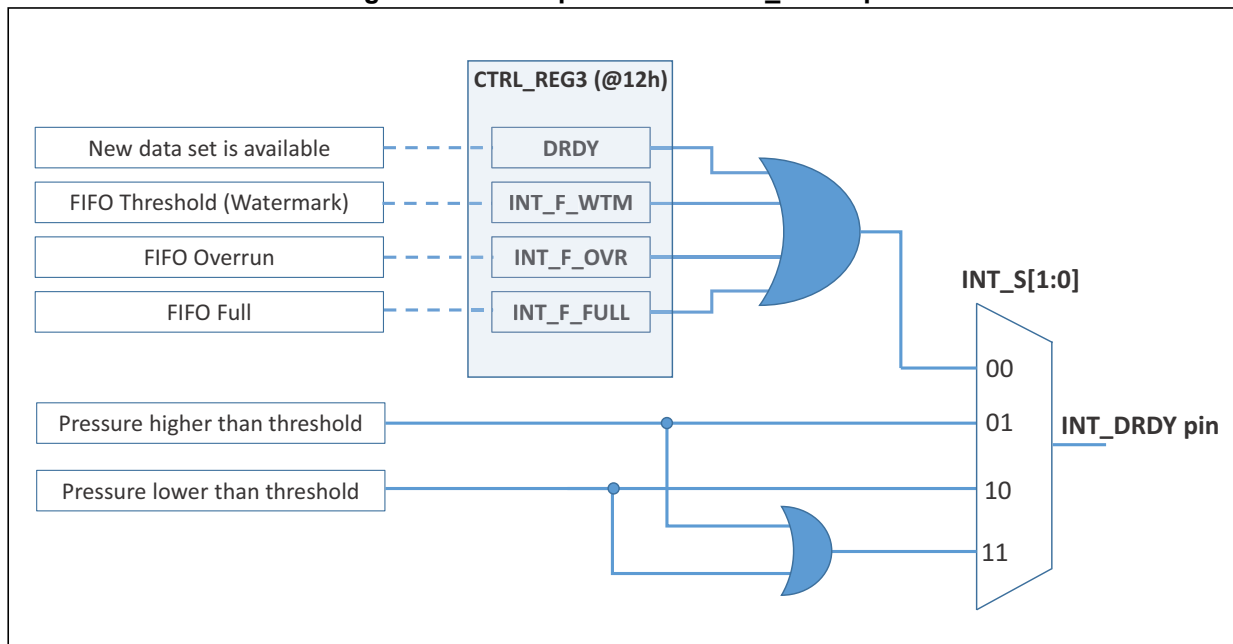
  

INT_F_FULL	FIFO full flag on INT_DRDY pin. Default value: 0 (0: FIFO empty; 1: FIFO full - 128 unread samples)
INT_F_WTM	FIFO threshold (watermark) status on INT_DRDY pin. Default value: 0 (0: FIFO is lower than FTH level; 1: FIFO is equal to or higher than FTH level)
INT_F_OVR	FIFO overrun status on INT_DRDY pin. Default value: 0 (0: not overwritten; 1: at least one sample in the FIFO has been overwritten)
DRDY	Data-ready signal on INT_DRDY pin. Default value: 0 (0: disable; 1: enable)
INT_S[1:0]	Data signal on INT_DRDY pin control bits. Default value: 00 Refer to <a href="#">Table 20</a> .

**Table 20. Interrupt configurations**

INT_S1	INT_S0	INT_DRDY pin configuration
0	0	Data signal (in order of priority: DRDY or INT_F_WTM or INT_F_OVR or INT_F_FULL)
0	1	Pressure high (P_high)
1	0	Pressure low (P_low)
1	1	Pressure low OR high

**Figure 23. Interrupt events on INT\_DRDY pin**



## 9.9 FIFO\_CTRL (13h)

FIFO control register (R/W)

7	6	5	4	3	2	1	0
0	0	0	0	STOP_ON_WTM	TRIG_MODES	F_MODE1	F_MODE0
STOP_ON_WTM		Stop-on-FIFO watermark. Enables FIFO watermark level use. Default value: 0 (0: disable; 1: enable)					
TRIG_MODES		Enables triggered FIFO modes. Default value: 0					
F_MODE[1:0]		Selects triggered FIFO modes. Default value: 00 Refer to <a href="#">Table 21</a> .					

**Table 21. FIFO mode selection**

TRIG_MODES	F_MODE[1:]	Mode
x	00	Bypass
0	01	FIFO mode
0	1x	Continuous (Dynamic-Stream)
1	01	Bypass-to-FIFO
1	10	Bypass-to-Continuous (Dynamic-Stream)
1	11	Continuous (Dynamic-Stream)-to-FIFO

The STOP\_ON\_WTM bit enables the use of the FIFO watermark level: when the number of samples in FIFO is equal to the watermark level (set using the WTM[4:0] bits in [FIFO\\_WTM \(14h\)](#)) then FIFO is full.

The TRIG\_MODES bit enables the triggered FIFO modes.

The F\_MODE[1:0] bits select one of the FIFO modes, as described in [Table 21](#).

Output data (pressure and temperature) are read through [FIFO\\_DATA\\_OUT\\_PRESS\\_XL \(78h\)](#), [FIFO\\_DATA\\_OUT\\_PRESS\\_L \(79h\)](#), [FIFO\\_DATA\\_OUT\\_PRESS\\_H \(7Ah\)](#), [FIFO\\_DATA\\_OUT\\_TEMP\\_L \(7Bh\)](#) and [FIFO\\_DATA\\_OUT\\_TEMP\\_H \(7Ch\)](#); both single read and multiple read operations can be used.

### 9.10 FIFO\_WTM (14h)

FIFO threshold setting register (R/W)

7	6	5	4	3	2	1	0
0	WTM6	WTM5	WTM4	WTM3	WTM2	WTM1	WTM0
WTM[6:0]		FIFO threshold. Watermark level setting. Default value: 00000000					

### 9.11 REF\_P\_L (15h)

Reference pressure LSB data (R)

7	6	5	4	3	2	1	0
REFL7	REFL6	REFL5	REFL4	REFL3	REFL2	REFL1	REFL0
REFL[7:0]		This register contains the low part of the reference pressure value. Default value: 00000000					

The Reference pressure value is 16-bit data and it is composed of [REF\\_P\\_H \(16h\)](#) and [REF\\_P\\_L \(15h\)](#). The value is expressed as 2's complement.

The reference pressure value is stored and used when the AUTOZERO or AUTOREFP function is enabled. Please refer to the [INTERRUPT\\_CFG \(0Bh\)](#) register description.

### 9.12 REF\_P\_H (16h)

Reference pressure MSB data (R)

7	6	5	4	3	2	1	0
REFL15	REFL14	REFL13	REFL12	REFL11	REFL10	REFL9	REFL8
REFL[15:8]		This register contains the high part of the reference pressure value. Default value: 00000000					

### 9.13 RPDS\_L (18h)

Pressure offset (LSB data)

	7	6	5	4	3	2	1	0
	RPDS7	RPDS6	RPDS5	RPDS4	RPDS3	RPDS2	RPDS1	RPDS0

RPDS[7:0]	This register contains the low part of the pressure offset value. Default value: 00000000
-----------	--

The pressure offset value is 16-bit data that can be used to implement one-point calibration (OPC) after soldering. This value is composed of *RPDS\_H (19h)* and *RPDS\_L (18h)*. The value is expressed as 2's complement.

### 9.14 RPDS\_H (19h)

Pressure offset (MSB data)

	7	6	5	4	3	2	1	0
	RPDS15	RPDS14	RPDS13	RPDS12	RPDS11	RPDS10	RPDS9	RPDS8

RPDS[15:8]	This register contains the high part of the pressure offset value. Refer to <i>RPDS_L (18h)</i> . Default value: 00000000
------------	--

### 9.15 INT\_SOURCE (24h)

Interrupt source (read only)

	7	6	5	4	3	2	1	0
	BOOT_ON	0	0	0	0	IA	PL	PH

BOOT_ON	Indication of Boot phase. (0: Boot phase has ended; 1: Boot phase is running).
IA	Interrupt active. (0: no interrupt has been generated; 1: one or more interrupt events have been generated).
PL	Differential pressure Low. (0: no interrupt has been generated; 1: low differential pressure event has occurred).
PH	Differential pressure High. (0: no interrupt has been generated; 1: high differential pressure event has occurred).

## 9.16 FIFO\_STATUS1 (25h)

FIFO status register (read only)

7	6	5	4	3	2	1	0
FSS7	FSS6	FSS5	FSS4	FSS3	FSS2	FSS1	FSS0
FSS[7:0]		FIFO stored data level, number of unread samples stored in FIFO. (00000000: FIFO empty; 10000000: FIFO full, 128 unread samples)					

## 9.17 FIFO\_STATUS2 (26h)

FIFO status register (read only)

7	6	5	4	3	2	1	0
FIFO_WTM_IA	FIFO_OVR_IA	FIFO_FULL_IA	-	-	-	-	-
FIFO_WTM_IA	FIFO threshold (watermark) status. Default value: 0 (0: FIFO filling is lower than treshold level; 1: FIFO filling is equal or higher than treshold level).						
FIFO_OVR_IA	FIFO overrun status. Default value: 0 (0: FIFO is not completely full; 1: FIFO is full and at least one sample in the FIFO has been overwritten).						
FIFO_FULL_IA	FIFO full status. Default value: 0 (0: FIFO is not completely filled; 1: FIFO is completely filled, no samples overwritten)						

## 9.18 STATUS (27h)

Status register (read only)

7	6	5	4	3	2	1	0
--	--	T_OR	P_OR	--	--	T_DA	P_DA
T_OR	Temperature data overrun. (0: no overrun has occurred; 1: a new data for temperature has overwritten the previous data)						
P_OR	Pressure data overrun. (0: no overrun has occurred; 1: new data for pressure has overwritten the previous data)						
T_DA	Temperature data available. (0: new data for temperature is not yet available; 1: a new temperature data is generated)						
P_DA	Pressure data available. (0: new data for pressure is not yet available; 1: a new pressure data is generated)						

This register is updated every ODR cycle.

### 9.19 PRESS\_OUT\_XL (28h)

Pressure output value LSB data (read only)

7	6	5	4	3	2	1	0
POUT7	POUT6	POUT5	POUT4	POUT3	POUT2	POUT1	POUT0

POUT[7:0]	This register contains the low part of the pressure output value.
-----------	---

The pressure output value is a 24-bit data that contains the measured pressure. It is composed of [PRESS\\_OUT\\_H \(2Ah\)](#), [PRESS\\_OUT\\_L \(29h\)](#) and [PRESS\\_OUT\\_XL \(28h\)](#). The value is expressed as 2's complement.

The output pressure register **PRESS\_OUT** is provided as the difference between the measured pressure and the content of the register RPDS (18h, 19h)\*.

Please refer to [Section 4.4: Interpreting pressure readings](#) for additional info.

\*DIFF\_EN = '0', AUTOZERO = '0', AUTOREFP = '0'

### 9.20 PRESS\_OUT\_L (29h)

Pressure output value middle data (read only)

7	6	5	4	3	2	1	0
POUT15	POUT14	POUT13	POUT12	POUT11	POUT10	POUT9	POUT8

POUT[15:8]	This register contains the mid part of the pressure output value. Refer to <a href="#">PRESS_OUT_XL (28h)</a>
------------	--

### 9.21 PRESS\_OUT\_H (2Ah)

Pressure output value MSB data (read only)

7	6	5	4	3	2	1	0
POUT23	POUT22	POUT21	POUT20	POUT19	POUT18	POUT17	POUT16

POUT[23:16]	This register contains the high part of the pressure output value. Refer to <a href="#">PRESS_OUT_XL (28h)</a>
-------------	---



## 9.22 TEMP\_OUT\_L (2Bh)

Temperature output value LSB data (read only)

7	6	5	4	3	2	1	0
TOUT7	TOUT6	TOUT5	TOUT4	TOUT3	TOUT2	TOUT1	TOUT0
TOUT[7:0]		This register contains the low part of the temperature output value.					

The temperature output value is 16-bit data that contains the measured temperature. It is composed of *TEMP\_OUT\_H (2Ch)*, and *TEMP\_OUT\_L (2Bh)*. The value is expressed as 2's complement.

## 9.23 TEMP\_OUT\_H (2Ch)

Temperature output value MSB data (read only)

7	6	5	4	3	2	1	0
TOUT15	TOUT14	TOUT13	TOUT12	TOUT11	TOUT10	TOUT9	TOUT8
TOUT[15:8]		This register contains the high part of the temperature output value.					

## 9.24 FIFO\_DATA\_OUT\_PRESS\_XL (78h)

FIFO pressure output LSB data (read only)

7	6	5	4	3	2	1	0
FIFO_P7	FIFO_P6	FIFO_P5	FIFO_P4	FIFO_P3	FIFO_P2	FIFO_P1	FIFO_P0
FIFO_P[7:0]		Pressure LSB data in FIFO buffer					

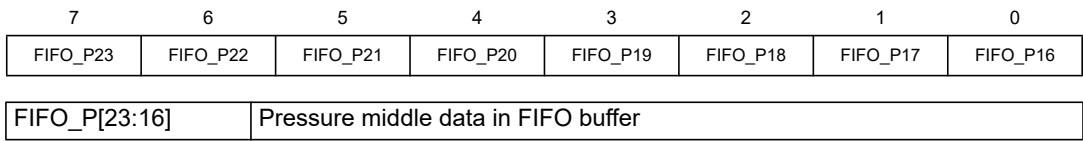
## 9.25 FIFO\_DATA\_OUT\_PRESS\_L (79h)

FIFO pressure output middle data (read only)

7	6	5	4	3	2	1	0
FIFO_P15	FIFO_P14	FIFO_P13	FIFO_P12	FIFO_P11	FIFO_P10	FIFO_P9	FIFO_P8
FIFO_P[15:8]		Pressure middle data in FIFO buffer					

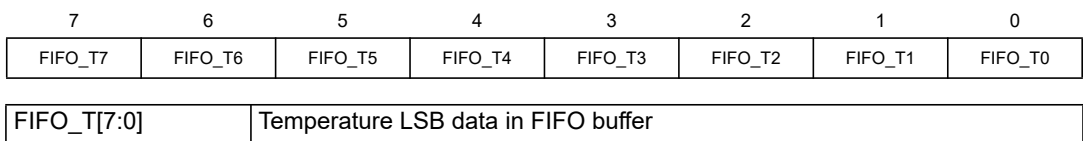
### 9.26 FIFO\_DATA\_OUT\_PRESS\_H (7Ah)

FIFO pressure output MSB data (read only)



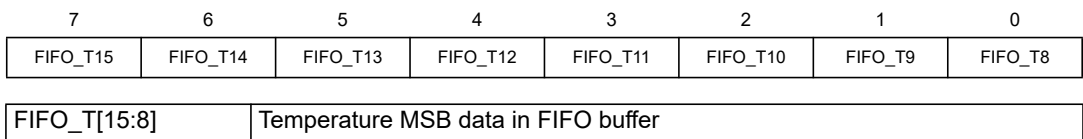
### 9.27 FIFO\_DATA\_OUT\_TEMP\_L (7Bh)

FIFO temperature output LSB data (read only)



### 9.28 FIFO\_DATA\_OUT\_TEMP\_H (7Ch)

FIFO temperature output MSB data (read only)

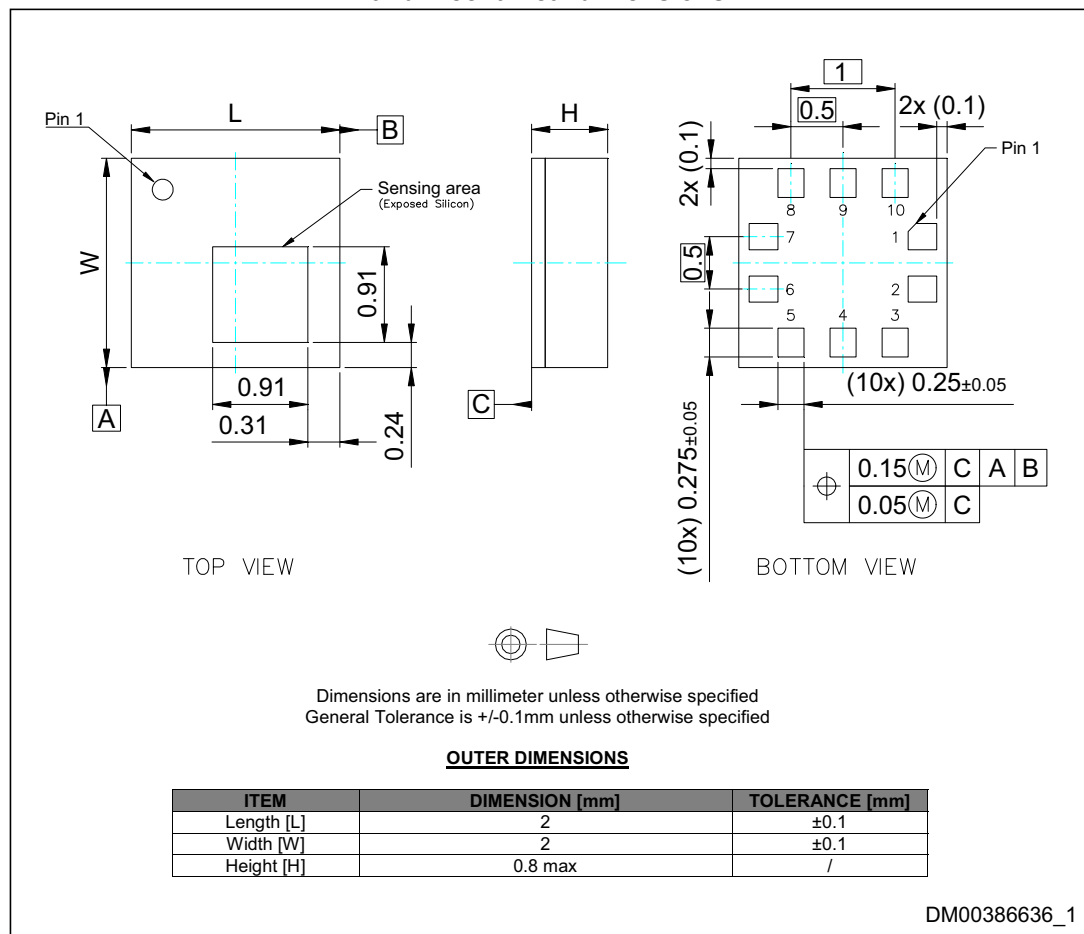


# 10 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

## 10.1 HLGA-10L package information

Figure 24. HLGA-10L (2.0 x 2.0 x 0.76 mm typ.) package outline and mechanical dimensions



## 10.2 HLGA-10L packing information

Figure 25. Carrier tape information for HLGA-10L package

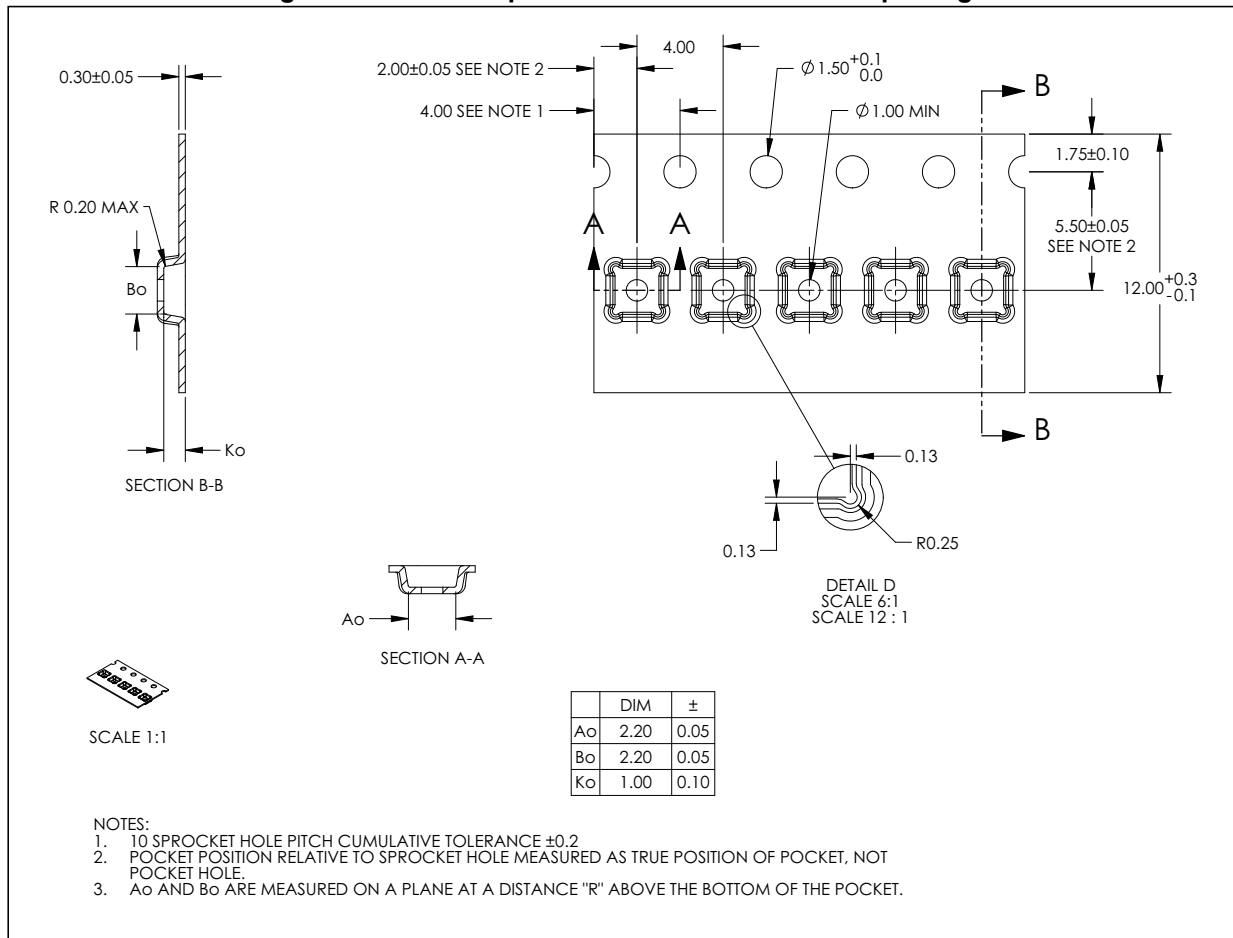


Figure 26. HLGA-10L package orientation in carrier tape

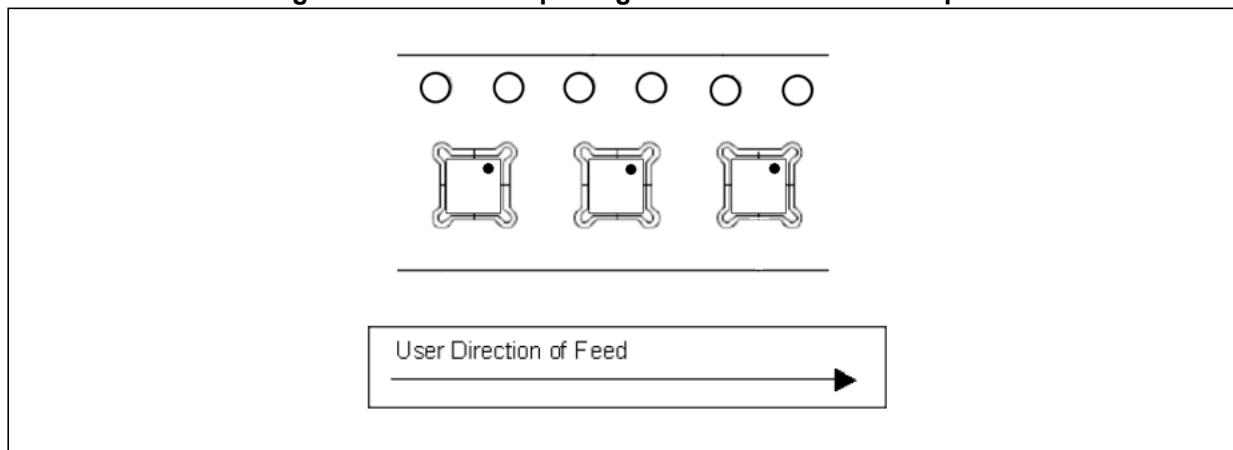


Figure 27. Reel information for carrier tape of HLGA-10L package

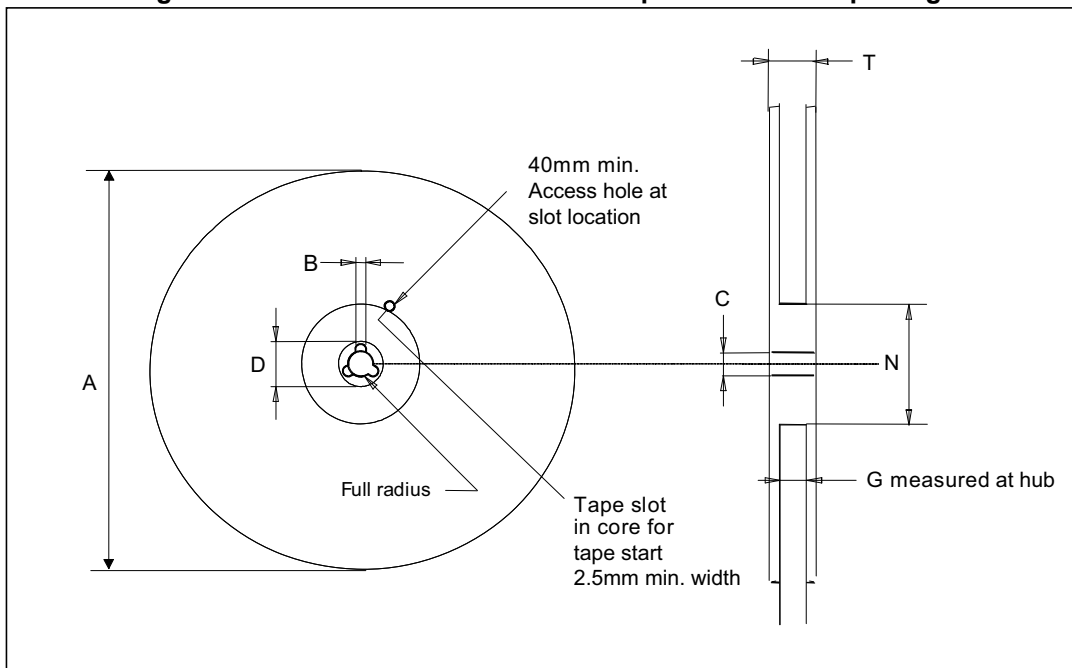


Table 22. Reel dimensions for carrier tape of HLGA-10L package

Reel dimensions (mm)	
A (max)	330
B (min)	1.5
C	13 ±0.25
D (min)	20.2
N (min)	60
G	12.4 +2/-0
T (max)	18.4

## 11 Revision history

**Table 23. Document revision history**

Date	Revision	Changes
05-Aug-2020	2	First public release

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